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Perovskite materials in X-ray detection and imaging: recent progress, challenges, and future prospects

Md. Helal Miah, ^{Dab} Mayeen Uddin Khan[dake](http://orcid.org/0000-0001-5370-7358)r[,](http://orcid.org/0000-0003-3772-294X) D^{*ac} Mohammad [Ami](http://orcid.org/0000-0002-7675-8681)nul Islam,^d Mohammad Nur-E-Alam, ^{ef} Hamid Osman ¹⁹ and Md. Habib Ullah ¹⁹ h

Perovskite materials have attracted significant attention as innovative and efficient X-ray detectors owing to their unique properties compared to traditional X-ray detectors. Herein, chronologically, we present an indepth analysis of X-ray detection technologies employing organic–inorganic hybrids (OIHs), all-inorganic and lead-free perovskite material-based single crystals (SCs), thin/thick films and wafers. Particularly, this review systematically scrutinizes the advancement of the diverse synthesis methods, structural modifications, and device architectures exploited to enhance the radiation sensing performance. In addition, a critical analysis of the crucial factors affecting the performance of the devices is also provided. Our findings revealed that the improvement from single crystallization techniques dominated the film and wafer growth techniques. The probable reason for this is that SC-based devices display a lower trap density, higher resistivity, large carrier mobility and lifetime compared to film- and waferbased devices. Ultimately, devices with SCs showed outstanding sensitivity and the lowest detectable dose rate (LDDR). These results are superior to some traditional X-ray detectors such as amorphous selenium and CZT. In addition, the limited performance of film-based devices is attributed to the defect formation in the bulk film, surfaces, and grain boundaries. However, wafer-based devices showed the worst performance because of the formation of voids, which impede the movement of charge carriers. We also observed that by performing structural modification, various research groups achieved highperformance devices together with stability. Finally, by fusing the findings from diverse research works, we provide a valuable resource for researchers in the field of X-ray detection, imaging and materials science. Ultimately, this review will serve as a roadmap for directing the difficulties associated with perovskite materials in X-ray detection and imaging, proposing insights into the recent status, challenges, and promising directions for future research. **PEVIEW PERIOD Section and CERT CONSISTED MATERIALS In X-ray detection and CERT CONSISTED CRIMINALS (The this RSC AN), 2004, 14 4656

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a Applied Physics and Radiation Technologies Group, CCDCU, School of Engineering

and Technology, Sunway University, Bandar Sunway 47500, Selangor, Malaysia b Department of Physics, Bangabandhu Sheikh Mujibur Rahman Science and

Technology University, Gopalganj 8100, Bangladesh

Faculty of Graduate Studies, Daffodil International University, Daffodil Smart City, Birulia, Savar, Dhaka, 1216, Bangladesh. E-mail: mayeenk@diu.edu.bd; mu_khandaker@yahoo.com

1. Introduction

The sensing and imaging of high-energy ionizing radiation, particularly X-rays, is important for diverse applications including homeland security, national defense, medical imaging, sustainable energy, industrial monitoring, environmental surveys, non-destructive inspection, and fundamental scientific research.^{1,2} For example, X-ray computed tomography imaging has been widely utilized to examine lung infections linked with the COVID-19 disease, which aids in the comprehensive understanding of the disease.³⁻⁶ Solid-state semiconductor-based radiation detectors offer several benefits due to their unique properties and capabilities in the gas field, together with scintillating material-based high-energy radiation detectors such as X-ray detectors.⁷ Experimentally, it has been proven that 300 000 electron–hole pairs are generated by 1 MeV energy in a semiconductor, which is about 10 times higher than the number of ion pairs generated by the same energy in a gas chamber.⁸ Consequently, it improves the signal-to-noise ratio in

^aDepartment of Electrical Engineering, Faculty of Engineering, Universiti Malaya, Kuala Lumpur 50603, Selangor, Malaysia

e Institute of Sustainable Energy, Universiti Tenaga Nasional, Jalan IKRAM-UNITEN, Kajang 43000, Selangor, Malaysia

f School of Science, Edith Cowan University, 270 Joondalup Drive, Joondalup-6027, WA, Australia

g Department of Radiological Sciences, College of Applied Medical Sciences, Taif University, 21944 Taif, Saudi Arabia

^hDepartment of Physics, Faculty of Science and Technology, American International University-Bangladesh, 408/1, Kuratoli, Khilkhet, Dhaka 1229, Bangladesh

comparison with a pulse-type signal in an ion chamber. Besides this benefit, high-energy particles including alpha/beta can only traverse a short distance typically in the range of micrometers/ millimeters, which would be a few centimeters/meters in gases at ambient pressure.⁹ This indicates that a relatively thin radiation detector can fully absorb the whole energy of the incident particle. During the penetration of high-energy particles in a semiconducting material, the energy loss to the valence band

electron elevates at the conduction band by generating an electron–hole pair. In semiconductor detectors, an electric field is applied across the detector to drift the electrons and holes toward their respective electrodes, and the corresponding output signal is generated.¹⁰ The complete procedure is depicted in Fig. 1.

The effectiveness of X-ray detectors relies on the high sensitivity and detection efficiency of weak and high-energy X-

Fig. 1 Working principle of a radiation detector.

Fig. 2 Comparison of (a) atomic structure, (b) electronic behavior, (c) material characteristics, and (d and e) electrical properties of perovskite materials with different semiconducting materials for high-energy radiation detectors.^{31–39}

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rays. The performance of X-ray-detecting semiconducting materials is closely related to their average atomic number, charge carrier mobility, and carrier lifetime.¹¹⁻¹³ To date, only a few compounds have been commercially employed for sensing and imaging X-ray radiation, including silicon (Si), amorphous selenium $(\alpha$ -Se), germanium (Ge), and cadmium zinc telluride (CdZnTe). However, these types of detectors have several drawbacks including low average atomic number, large leakage currents, low X-ray attenuation coefficient, high production costs, relative chemical toxicity, poor mechanical qualities, and increasing performance deterioration with time owing to the polarization effect.¹⁴ Thus, it is essential to explore new materials to replace the conventional materials for X-ray sensing and imaging.

A new class of materials known as perovskites has emerged, which is expressed by the stoichiometric formula $ABM₃$, where A represents a monovalent inorganic/organic cation, B represents a divalent metal cation and M signifies a halide anion.¹⁵ The halogens can also be replaced by oxygen, nitrogen, or carbon. Usually, A and B are shown as divalent and tetravalent ions, respectively, with oxygen used for charge neutrality instead of halogen. To preserve the charge neutrality, the cubic perovskite structure is made up of corner-sharing $BM₆$ octahedra, which produce a 3D network, where the A site cations reside in the 12-fold coordinated (cuboctahedral) vacancies. Alternatively, perovskite materials may be observed as a cubic close-packed AM3 sub-lattice comprised of divalent B-site cations inside the six-fold coordinated (octahedral) cavities.¹⁶

To date, these materials have shown promise in multifaceted applications with high efficacy such as photovoltaic solar cells, magnetic memory devices, gas sensing, bio-imaging, light-emitting diodes, and solid-state fuel cells.¹⁷⁻²² From 2009 onward, the photovoltaic research community has achieved an enhancement in the PCE from 3.81% to 25.8% by gaining a thorough grasp of the essential properties of perovskites and functional device approaches.^{23,24} In recent years, perovskite materials have appeared as new promising materials for ionizing radiation sensing owing to their exclusive benefits including high average atomic number Z (to absorb high-energy photons), appropriate bandgap energy, high resistivity, large mobility–lifetime product (a high capacity to gather carriers), low production cost, excellent charge carrier transportation properties, and outstanding tolerance to defects.²⁵–³⁰ The superior features of perovskite materials in comparison with other semiconducting materials used commercially are depicted in Fig. 2(a)–(e). This indicates why researchers have been attempting to use perovskite materials for radiation detection.

In this study, we provide a comprehensive review on X-ray detection directly by overviewing the evolution of perovskite materials, innovation and modification of their synthesis process with cost-effective techniques and the device architectural modification. In addition, we discuss the fundamental properties of materials and devices in regard to radiation detection and their working principle. Moreover, we discuss the potentiality of OIH perovskites, all-inorganic perovskites and lead-free perovskites as X-ray detectors.

Fig. 3 Brief essence of this review.

Finally, the existing problems associated with perovskites as X-ray detectors are discussed and the future possibility of research presented. The essence of our review work is depicted in Fig. 3.

2. Fundamentals of radiation detecting materials and devices

In this section, we focus on exploring the details of both material and device characteristics, with precise emphasis on the interdependence between them. The characteristics and features of devices are necessarily shaped by the innate properties of the materials employed. In the realm of material properties, we investigated aspects such as radiation attenuation ratio, ionization energy, and the mobility–lifetime product. In parallel, the discussion is extended to device-specific properties, covering parameters such as dark current, charge collection efficiency, sensitivity, limit of detection, and response time. This comprehensive exploration aims to explain the intricate relationship between material characteristics and the performance metrics of corresponding devices.

2.1. Radiation attenuation ratio

The attenuation of incident radiation occurs due to the interaction of incident radiation with materials through mainly Rayleigh scattering, photoelectric effects, Compton scattering, and pair production processes. This attenuation can be estimated by the Beer–Lambert law, which is expressed by eqn (1), as follows:

$$
I = I_0 e^{-\left(-\left(\frac{\mu}{\rho}\right)x\right)}
$$
 (1)

where I represents the intensity of the attenuated radiation, I_0 indicates the initial intensity of incident radiation, μ denotes the linear attenuation coefficient, ρ signifies the density of the material and x symbolizes the distance radiation penetrates into the material. Researchers in the field of radiation use μ to compare the attenuation ability of numerous materials upon exposure to radiation. It gives information on how a material interacts with incident radiation. A higher value of μ for a material indicates its high ability to attenuate (more absorption) radiation. The linear attenuation coefficient in inverse length units can be expressed as follows (2):

$$
\mu \propto \frac{\rho Z^4}{A E^3} \tag{2}
$$

where Z indicates the atomic number of the material, A specifies the atomic mass and E represents the energy of the incident radiation. In addition, the mass attenuation coefficient is another way to predict a the attenuation capability of a material, which signifies the linear attenuation coefficient normalized by the density of the material. Consequently, a constant value is obtained for a specific element or compound. This constant value is a characteristic feature that helps to compare and quantify the ability of a material regarding radiation attenuation irrespective of its mass or thickness. In the case of direct detection, the ideal materials possess a high atomic number Z (>40) for completely absorbing incident radiation and converting it into electrical signals.⁴⁰ This is consistent with halide perovskite materials from the aspect of the atomic number of their elements such as Pb, I, Cs, and Ag. Thus, perovskite materials possess higher atomic numbers in comparison with some conventional materials such as Si $(Z = 14)$ and α -Se $(Z =$ 34). It can be shown that under 50 keV X-ray photons, for completely absorbing this radiation, the required thickness of halide perovskite lies between the thickness of CZT and α -Se material. In brief, it can be said that a perovskite material with a high atomic number and moderate density is a promising candidate for radiation detection.⁴¹ Review Wextbooks Articles. Published on 22 February 2022. The constrained on 22 February 2022. The method on 12 February 2022. The creation of the creation o

The attenuation ratio, denoted by ε , of a material can be expressed with a thickness of L by eqn (3) , as follows:

$$
\varepsilon = 1 - e^{-\mu L} \tag{3}
$$

The number of photons absorbed per second by the material is defined by the absorption rate, which can be explained according to eqn (4), as follows:

$$
\varphi = \frac{\varepsilon Dm}{E} \tag{4}
$$

where D denotes the dose rate and m represents the mass of material.

2.2. Ionization energy

The ionization energy is the amount of energy required to produce an electron–hole pair in a material. In the case of the majority of semiconducting materials, the ionization energy is solely related to their band gap and follows empirical formula (5) :⁴²

$$
W = A \times E_{\rm g} + B \tag{5}
$$

where W denotes the ionization energy, $E_{\rm g}$ specifies the bandgap, and A and B are constants. According to the literature, this energy for most of the perovskite materials can be described by eqn (6), which is nearly an order of magnitude lower than the ionization energy of α -Se.⁴³

$$
W = 2Eg + 1.43 \text{ eV}
$$
 (6)

When perovskites and amorphous selenium are exposed to the same dose of high-energy photons, perovskites produce an order of magnitude more electron–hole pairs in comparison with amorphous selenium. This suggests that perovskite materials are highly encouraging semiconductors as the absorbing layer in high-energy photon detectors.

2.3. Charge collection efficiency

The charge collection efficiency (CCE) represents the ratio of the total charge collected by the electrode to the total charge generated within a material when it is exposed to radiation. Alternatively, it can be defined as the measurement of how effectively a detector can convert incident radiation into a measurable electrical signal. A higher CCE signifies superior performance in terms of perfectly detecting and quantifying radiation. Theoretically, one can calculate the number of electron–hole pairs created by a high-energy photon using eqn (7).

$$
\beta = \frac{E}{W} \tag{7}
$$

where β represents the highest number of radiation-generated carriers. These radiation-generated electron–hole pairs will drift toward their respective electrode under a bias and generate an electronic signal in the external circuit.

Theoretically, the maximum light-generated current (I_p) can be expressed by eqn (8), as follows:

$$
I_{\rm p} = \beta e \tag{8}
$$

where e denotes the electronic charge. By considering the carrier loss due to recombination and trapping, the modified Hecht eqn (9) can be adopted to estimate the actual photogeneration current accumulated by the electrodes.⁴⁴

$$
I = I_0 \frac{\mu \tau V}{L^2} \frac{1 - e^{-\left(-\frac{L^2}{\mu \tau V}\right)}}{1 + \frac{L}{V} \frac{s}{\mu}}
$$
(9)

where I_0 represents the saturated photocurrent, L denotes the thickness of the material layer, V signifies the bias voltage, S indicates the surface recombination rate, τ symbolizes the carrier lifetime and μ stands for the carrier mobility. Now the charge collection efficiency (CCE) can be expressed by eqn (10).⁴⁵

$$
\text{CCE} = \frac{\mu \tau V}{L^2} \left[1 - e^{\left(- \frac{L^2}{\mu \tau V} \right)} \right]
$$
(10)

2.4. Dark current

The current–voltage relation for the single diode equation or the Shockley diode equation is given by (11), as follows:

$$
I = I_0 \left[\exp\left(\frac{q(V - JR_{\rm s})}{nkT}\right) - 1 \right] + \frac{V - JR_{\rm s}}{R_{\rm sh}} \tag{11}
$$

where *n* represents the ideality factor, I_0 indicates the reverse saturated current, $R_{\rm sh}$ signifies the shunt resistance and $R_{\rm s}$ symbolizes the series resistance and k , T , and q represent the Boltzmann constant, temperature, and electronic charge, respectively. In the absence of light, the reverse saturated current is known as the dark current (I_{dark}) . In some electronic devices, particularly radiation detectors, this reverse saturation current can contribute to noise in the signal. A lower I_{dark} value can result in devices with lower noise levels and improved sensitivity to weak optical signals. In addition, a lower value of I_{dark} also contributes to better energy resolution by reducing the electronic noise. Normally, semiconducting materials with high resistivity display a low I_{dark} in devices.⁴⁶ In addition, halide perovskite materials retain high resistivity in the range of $10^7 - 10^{12}$ Q cm, which is
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2.5. Sensitivity

Sensitivity in radiation detection refers to the capability of a radiation detector to efficiently detect radiation. The high sensitivity of a radiation detector is a key parameter because it can shorten the exposure time as well as reduce the risk of ionizing radiation. In addition, a highly sensitive radiation detector generates a substantial electronic signal when exposed to the same radiation and enhances its distinct identification capabilities. Typically, sensitivity is explained by the accumulation of charge per unit area under exposure to radiation. The sensitivity can be expressed by eqn $(12).49$

$$
S = \frac{I_{\text{radiation}} - I_{\text{dark}}}{DA} \tag{12}
$$

where $I_{\text{radiation}}/I_{\text{dark}}$, D, and A are the output current with/ without X-ray irradiation, the X-ray irradiation dose rate and sensing area, respectively.

In addition, the sensitivity of a detector can also be expressed by eqn $(13).50$

$$
S = \frac{I_{\text{radiation}} - I_{\text{dark}}}{DV} \tag{13}
$$

where V represents the volume of the detector. Moreover, the sensitivity of the device is influenced by the radiation attenuation, carrier extraction, electron–hole generation, and photoconductivity gain.⁵¹

2.6. Limit of detection

Noise influences the sensitivity and the LDDR of the detector via noise current. There are four types of noise current including shot noise (i_{shot}) , thermal noise $(i_{thermal})$, generationrecombination noise (i_{g-r}) and flicker noise $\sqrt{2}$ $\begin{pmatrix} i_1 \\ -i_2 \end{pmatrix}$ f \setminus \cdot The thermal

and shot noise are frequency independent and called white noise. Alternatively, the generation–recombination and flicker noise are frequency dependent.⁵² In addition, it has been reported that large resistivity can reduce the shot noise, and a large band gap leads to low thermal noise.⁵³ Thus, a high resistance and large band gap are criteria for materials that can be used as a detector. The International Union of Pure and Applied Chemistry (IUPAC) declared that the detection limit of the producing signal value is three times the noise⁵⁴ and the scientific community employs a signal-to-noise ratio (SNR) value of three to describe the limit of detection in radiation detection, especially X-ray detectors.⁵⁵ The SNR is expressed by eqn (14).⁵⁶

$$
SNR = \frac{J_s}{J_n} \tag{14}
$$

$$
J_{\rm s} = J_{\rm radiation} - J_{\rm dark} \tag{14a}
$$

$$
J_{\rm n} = \sqrt{\frac{1}{N} \sum_{i}^{N} (J_i - J_{\rm radiation})^2}
$$
 (14b)

where J_s , J_n , $J_{radiation}$ and J_{dark} indicates the signal current density, noise current density, photo-current density and dark current density, respectively. Two key factors $(J_{\text{radiation}}$ and $J_{\text{dark}})$ that meaningfully influence the SNR are the introduction of carriers from both contact interfaces and the existence of thermally activated carriers within the intrinsic material.⁵⁷

2.7. Mobility–lifetime product

The mobility (μ) –lifetime (τ) product of charge carriers is a central and crucial parameter that is employed to assess the quality and performance of extracting charge carriers from deep inside a material. It is directly correlated with the efficient collection of charge carriers produced by incident radiation. $\mu\tau$ can be obtained by fitting the data in the Hecht plot (9). Also, $\mu\tau$ is adopted to estimate the diffusion length of charge carriers using the eqn (15), as follows:

$$
L_{\rm D} = \left(\frac{k_{\rm B}T\mu\tau}{e}\right)^{1/2} \tag{15}
$$

The diffusion length of holes, $L_{\text{D}}^{h^{+}}$ (10–50 μ m) is typically larger than that of electrons $L_{\rm D}^{\rm e^-}$ (1–5 μ m).⁵⁸ Thus, perovskite-
based direct detectors function in hole sollection mode based direct detectors function in hole collection mode. Generally, a longer diffusion length helps the carriers to accumulate at the respective electrode. In the case of radiation detectors, a longer L_D is preferable because several millimeterthick perovskite materials are used for completely absorbing high-energy radiation. Thus, the scientific community has attempted to increase L_D by enhancing the bias voltage although it initiates the I_{dark} , which hampers the device performance.⁵⁹ In this case, by adopting a few modifications

including structure design, optimized synthetic process and post-treatment, the $\mu\tau$ can be enhanced without initiating I_{dark} . For an example, W. Pan and team increased the $\mu\tau$ from 3.75 \times 10^{-3} cm² V⁻¹ to 6.3 × 10^{-3} cm² V⁻¹ for the SC structure of $Cs₂AgBiBr₆$ by adopting annealing post-treatment.⁶⁰

2.8. Response time

The response time is employed to assess how quickly a detector can sense, which is distinguished as the required time for a photo-current rising from 10% to 90% of the saturated photocurrent, and then falling from 90% to 10% of the saturated photo-current. Generally, the dropping time is larger than the rising time because it is closely related with the trap state and crystalline quality.⁶¹ For an example, Liu and group fabricated a perovskite-based X-ray detector using MA₃Bi₂I₉ SCs and obtained a rising time and dropping time of 266 μ s and 417 μ s, respectively.⁶² In the case of an ideal radiation detector, a short response time is required, which lessens the exposure time to radiation and enables its usage in imaging including fluoroscopy.

3. Active layer fabrication techniques

3.1. Single crystal

A renowned research team under the leadership of Jiayue Xu conducted a comprehensive overview of the recent progress in the crystal growth of metal halide perovskites.⁶³ Their study discussed the challenges associated with controlling growth defects and improving the crystal quality and provided an understanding of the trap states and defects in the crystals. Their discussion comprehended the advantages of employing perovskite single crystals over polycrystalline thin films in optoelectronic devices. Furthermore, they scrutinized several studies where the authors asserted that perovskite single crystals display fewer defects, lack grain boundaries, and exhibit superior ambient stability in comparison to polycrystalline thin films.⁶⁴ These attributes make high-quality perovskite single crystals more alluring for exploring their intrinsic physical properties and devising high-performance devices. As an illustration, they provided an example naming a trap density for a crystal (CsPbBr₃) that is reported to be 5–6 orders of magnitude lower than that of its polycrystalline film counterparts.⁶⁵ The majority of researchers used perovskite material-based SC structures for detecting high-energy radiation. Perovskite SCs are more beneficial in many ways such as they exhibit lower defects, lack of grain boundary scattering and offer lower intrinsic carrier concentration.^{66,67} Specifically, SC-based halide perovskite offers a large mobility–lifetime product, large diffusion length, and minimal I_dark . 68,69 These properties have a huge significance for rapid and efficient high-energy radiation detection. Since the early 2010s, the fascination has been growing with adopting organic SCs as active semiconducting materials in direct ionizing radiation detection. This attentiveness has been meaningfully boosted by the progress in solutiongrowth techniques by producing large, high-quality crystals.^{70,71} For instance, C. C. Stoumpos and team fabricated a perovskitebased radiation detector for the first time, where they obtained a large $\mu\tau$ product for holes, which was ten-times larger than that of the commercially available CZT.⁷² To date, many fabrication strategies have been adopted to synthesize large-scale perovskite-based SCs. These methods are described in the next subsection together with a schematic diagram.

3.1.1. Inverse-temperature crystallization (ITC). ITC is considered a rapid crystal growth technique for obtaining highquality, large-scale and controlled-shape perovskite SCs. It is also appropriate for materials that have high solubility at room temperature and low solubility at high temperature in particular solvents.73,74 In general, the solubility of a solute in a solvent decreases when the temperature of the solution or melt cools. Consequently, a crystal will be formed after the concentration of the solute exceeds its solubility limit. However, ITC exhibits the reverse scenario. In the ITC method, the solute is dissolved in the solvent at room temperature, and then the solution is gradually heated to reach a saturated state for growing SCs. Many researchers have adopted this ITC method to synthesize OIH perovskites such as $MA_3Bi_2I_9$ and $FAPbX_3$ (X = Cl, Br, I) and all-inorganic perovskites including $Cs_3Bi_2I_9$ ^{75,76} In the literature, we found that dimethyl sulfoxide (DMSO), N,Ndimethylformamide (DMF), and γ -butyrolactone (GBL) are used frequently as solvents in the growth of SCs. Recently some researchers used 3-(decyldimethylammonio)propanesulfonate inner salt (DPSI) as an additive to decrease the defect formation rate.⁷⁷ A schematic illustration of the ITC method is depicted in Fig. 4I(a) and (b).⁷⁸ Review Wext

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3.1.2. Temperature-lowering crystallization (TLC). TLC is a straightforward method employed for the growth of the SC perovskite active layer. In this method, the solution is gradually cooled at a controlled rate, and thus the perovskite solution can be oversaturated, starting to form an SC. Using this TLC method, rubrene SCs were developed with a volume of 1 cm^3 , which were employed for neutron detection.⁸⁰ In addition, X. Song and group fabricated large SCs of a metal-free halide perovskite named DABCO–NH₄Br₃ (DABCO = *N-N'*-diazabicyclo [2.2.2]octonium) by adopting the TLC technique, where the temperature of the solution was cooled at a rate of 5 °C/15 h in deionized water from 60 $\rm{^{\circ}C}$ to 25 $\rm{^{\circ}C}$.⁸¹ In another instance, W. Yuan and research team developed PEA-Cs₂AgBiBr₆ SCs by adopting the TLC method, where they decreased the temperature of the solution firstly from 150 °C to 110 °C at a rate of 2 °C h $^{-1}$, and then to 60 °C at a rate of 1 °C h $^{-1}$. $^{\rm s2}$ Additionally, it has been observed that the TLC method is more appropriate for the fabrication of perovskite SCs with low dimensionality due to its straightforward procedure. The crystallization process using this method is shown in Fig. 4II(a) and (b) .⁷⁸

3.1.3. Slow solvent evaporation method (SSE). SSE is a more facile technique to grow SCs in comparison with ITC and TLC. According to the SSE method, a concentrated solution is allowed to evaporate slowly overnight under ambient conditions in an uncovered beaker. Consequently, the solute concentration slowly increases due to the decrease in the amount of solvent, which initiates the formation of growth of crystallites.83,84 Indeed, almost all organic SCs have been fabricated by adopting SSE, which are used for the direct detection of

Fig. 4 Some promising SC growth methods: (I) (a) temperature-dependent solubility of CsPbBr₃ in DMSO⁷⁹ and (b) inverse temperature crystallization. (II) (a) Temperature-dependent solubility of CsPbBr₃ in water⁷⁹ and (b) temperature-lowering crystallization. (III) Solvent evaporation method; (IV) anti-solvent vapor-assisted method; (V) hydrothermal method; and (VI) Bridgman method.

high-energy radiation. For example, the SSE method shows its potentiality by developing SCs including 4-hydroxycyanobenzene (4HCB), 1,5-dinitronaphthalene (DNN), and 1,8 naphthaleneimide (NTI), which were utilized for the real-time detection of a highly energized particle with high accuracy.⁸⁵⁻⁸⁹ In another instance, $(CPA)_{4}AgBiBr_{8}$ perovskite SCs with the dimension of 5 mm \times 4 mm \times 2 mm were developed by adopting the slow evaporation process of the HBr solvent under ambient conditions.⁹⁰ It should be mentioned that it is generally tough to control the process in this SSE method due to its long-term evaporation. The technique of crystallization by this method is depicted in Fig. 4I II.

3.1.4. Anti-solvent vapor-assisted crystallization (AVC). D. Shi and research group developed the AVC technique for fabricating SCs.⁹¹ Later, H. Wei and team developed perovskite SCs based on $MAPbBr₃$ for the first time by employing this method for X-ray detection.⁹² In this method, a compatible antisolvent is introduced in the crystal precursor solution through slow diffusion, which encourages the formation of high-quality SCs. AVC is appropriate for materials that have high solubility in one solvent, whereas narrow solubility in another solvent. In this case, DMF, GBL, and DMSO are considered compatible solvents for dissolving the perovskite precursors, and chlorobenzene, dichloromethane, diethyl ether and benzene are the representative of anti-solvents.⁹³ However, although highquality and large-scale perovskite SCs can be achieved using this method, the growth rate is relatively sluggish, which constrains its practical application.⁹⁴ The entire procedure of crystallization by this technique is shown in Fig. 4IV. Review Web 1832. Articles Articles. Published a promising performance as an Xeng detectr.""This internal to the photos in the second of the second on 12 February 2022

3.1.5. Hydrothermal synthesis. The hydrothermal reaction generally represents heterogeneous reactions at elevated temperatures and pressures within a sealed container, which efficiently shortens the duration for crystal growth.⁹⁵ During this process, solid materials are dissolved or undergo a reaction with hot and pressurized water to form new crystals. This method also permits the synthesis of intricate perovskite SCs including $Yb^{3+}/Er^{3+}/Bi^{3+}$ co-doped $Cs_2Ag_{0.6}Na_{0.4}InCl_6$ and Cs_2 - $Ag_{0.6}Na_{0.4}In_{0.85}Bi_{0.15}Cl₆SCs.^{96,97} In addition, these crystals have$ been shown to be outstanding for use in X-ray scintillation applications. The crystallization procedure by this method is depicted in Fig. 4V.

3.1.6. The vapor transport method. This method is a new method for developing high-quality and large-scale SC perovskites. In this process, the precursor solution of the materials is vaporized and transported to a different location along with particular pressure and temperature, and then facilitated to condense and form crystals. Y. He and group successfully fabricated large-size and crack-free anti-perovskite SCs $Hg_3Q_2I_2$ $(Q = S, Se, and Te)$ for radiation detection applications by utilizing this method.⁹⁸ Furthermore, the crystal dimensions reached up to 7 mm \times 5 mm \times 3.5 mm and detector performance increased due to the presence of an organic polymer including polyethylene.⁹⁹

3.1.7. Bridgman synthesis. The Bridgman technique is one of the different types of melt growth methods, in which crystallization happens from a melt, where cooling a liquid below its freezing point leads to the fusion and subsequent solidification of the pure material.¹⁰⁰ During the synthesis of SCs, there is no potential source of impurities besides the contamination of the crucible material and the surroundings. In addition, the crystal growth rate is usually higher than other existing methods. According to this process, the perovskite precursor is melted when the silica ampule tube filled with perovskite precursor passes through the hottest region and the target material nucleates and grows as the ampule moves toward the cold region.¹⁰¹ In early 2013, C. C. Stoumpos and research group developed $CsPbBr₃ SC$ ingots with a diameter of 7 mm, which

exhibited a promising performance as an X-ray detector.¹⁰² This well-known method is shown in Fig. 4VI in detail.

3.2. Thin or thick film growth technique

Besides fabricating perovskite SCs, many researchers have focused on developing thick/thin films with the help of solution-based deposition techniques for the purpose of using them as active materials for detecting high-energy radiation. In this section, we discuss the different deposition processes for synthesizing thick- and thin-layer perovskites for use as radiation-detecting materials.

3.2.1. Spin coating process. The spin coating technique is one of the handy and extensively used techniques for fabricating thin films with controlled thickness and uniformity. According to this technique, the precursor solution is dropped onto the substrate, and then put on a spinning plate, which is rotated at a high angular velocity. As the solution spreads and the solvent evaporates, a uniform film is formed. The uniform and homogeneous thickness depends on the concentration of the solution, density and spinning rate of the rotor. In 2015, for the first time, Yakunin and colleagues fabricated a thin film of $MAPbI₃$ by adopting four spin-cast layers with a thickness ranging from 260 nm to 600 nm using the spin-coating process, which was utilized in an X-ray detector. Later, different research groups developed different perovskite films for radiation detection such as organic, hybrid, and inorganic perovskite films.¹⁰³⁻¹⁰⁵ This process is depicted in Fig. $5(a)$.

3.2.2. Spray deposition process. The spray deposition technique is a cost-effective and large-scale perovskite filmdeveloping methods. A spray coater is a specialized tool for uniform and controlled spray deposition. It is usually comprised of a nozzle or pump for solution distribution and a control system to move the substrate. In this process, the precursor solution is ejected from the nozzle as a droplet, and then this droplet particle hits the substrate. Over time, the droplets dry rapidly and form homogeneous films, the thickness of which can be adjusted by altering the deposition parameters including pressure, concentration, density and time.¹⁰⁶ For the first time, the well-known research group led by S. Yakunin developed a thick $MAPbI₃$ perovskite film (10-100 μ m) for X-ray detection application by employing the spray deposition process.¹⁰⁷ This technique is pictorially described in Fig. 5(b).

3.2.3. Aerosol-liquid–solid method (ALS). The ALS method is a smooth transition from aerosol to liquid, which has been used for the development of perovskite films. A suite of technical parameters including temperature, aerosol delivery rate and composition can be accurately controlled in the ALS method. The traditional solution-based methods including spin-coating faces a challenge in depositing a thick film on a substrate owing to limitations regarding the surface tension and viscosity. In contrast, the ALS method can successfully develop dense, highly crystalline perovskite films with low defects.¹⁰⁸ For example, W. Qian and research team demonstrated the application of the ALS method to facilitate the growth of s uniform $CsPbI₂Br-based perovskite film for$

Fig. 5 Various methods for developing films: (a) spin coating; (b) spray coating; (c) doctor blade coating; (d) inkjet printing method; and (e) ALS technique.

radiation detection and they showed that the thickness and grain size of the film were enhanced steadily with an increment in the growth time.¹⁰⁹ Fig. 5(e) pictorially elucidates this process.

3.2.4. Dissolution and recrystallization method. The dissolution and subsequent recrystallization technique is an effective chemical process for developing crystal growth, compound purification and synthesis of materials with specific characteristics. In this technique, the sharp point or spike of the outer surface of the film is dissolved in the original perovskite solution after repeating the process. This dissolved material precipitates and fills the holes on the surface of the film at the appropriate temperature. After repetition of this process, a smooth and dense perovskite film is attained. For instance, in 2019, Z. Gou and colleagues obtained a high-quality film of microcrystalline CsPbBr₃ after performing many repetition dissolutions and recrystallizations, providing a good route for attaining a high-performance X-ray detector.¹¹⁰ The SEM image of the film exhibited uneven surface with abundant gaps in the initial phase. However, with the repetition of the process, the CsPbBr₃ film transformed into a smoother, microscopically porous structure. This conversion revealed that the sharp

portion on the surface of the CsPbBr₃ film gradually dissolved in the perovskite solution and filled the voids.

3.2.5. Inkjet printing method. Inkjet printing is a wellestablished and commonly used method for developing films. This process is advantageous from the aspect of low development costs and simple and flexible process. In addition, no mask plate or lithography is needed. This method involves the ejection of droplets of solution on the substrate from a chamber of solution by piezoelectric or thermal actuators. In 2019, the prominent research group of J. Liu and colleagues developed 20 nm-thick $CsPbBr₃$ perovskite quantum dots for the first time by adopting the inkjet-printing method for the purpose of using them as an X-ray detector.¹¹¹ Different research groups relied on this method to develop quantum dot-based films.¹¹² It shows potential as an affordable and straightforward approach for the large-scale manufacturing of perovskite-based X-ray detectors with multi-channel arrays. This method is shown in Fig. 5(d).

3.2.6. Doctor blade method. The doctor-blade method is a very simple and facile technique where one blade is used as the tool. In general, it is adopted for the roll-to-roll printing process, where making mass customization is possible. In 2017, Y. C. Kim and research team synthesized an 830 µm-thick

polycrystalline $MAPbI₃$ film using a doctor blade as an initial example for the purpose of using it in radiation detection application.¹¹³ In 2023, J. Tan and research group manufactured a radiation detector based on the $MAPbI₃$ perovskite with a thickness of 16.5 μ m by adopting the doctor blade method.¹¹⁴ They also claimed that the sensitivity of the device was $127 \mu C$ Gy^{-1} cm⁻² under an irradiation dose rate of 0.1584 mGy s⁻¹ with good stability under ambient conditions for two months. This facile technique is depicted in Fig. 5(c).

3.2.7. Bar-assisted meniscus shearing method. A new and innovative approach named the bar-assisted meniscus shearing approach has been utilized to fabricate perovskite thin-films for application in radiation detection. This method involves the use of a solution of TIPS–pentacene and polystyrene to fabricate the detector. The research group led by I. Temiño showed that the coating speed and blend of bis(triisopropylsilylethynyl)pentacene:polystyrene are key tools to control the film morphology and carrier mobility, providing an enhancement in the detection capability of the device. They claimed that the recorded sensitivity of 1.3 × 10⁴ µC Gy⁻¹ cm⁻² and LDDR of 35 µGy s⁻¹ were obtained for organic-based direct X-ray radiation detectors.¹¹⁵

3.3. Wafer

3.3.1. Isostatic-Pressing method. The development of large-area and millimeter-thick perovskite films for radiation sensing and imaging applications remains a major issue. The inevitable solvent evaporation during the solution-based method leaves a large number of pinholes inside the films, which significantly inhibit the charge transportation and reduce the performance of the device. Different research groups prepared perovskite-based wafers, which require no solvent throughout the process and result in a pinhole-free and compact wafers. The isostatic pressing scheme is a wellknown method for preparing wafer-like structures. The isostatic pressing method provides an advantage in developing uniform and dense wafer structures, which can be useful in achieving high-quality perovskite wafers with better electrical and optical properties. According to this method, high-quality perovskite powder is prepared with an exact composition and particle size. Subsequently, the perovskite powder is placed in a flexible mold or container. Later, the mold containing the perovskite powder is exposed to high pressure uniformly from all directions by means of a fluid medium. This pressure causes the powder particles to

compact and adhere together, forming a solid structure with the desired shape and dimension. After the pressing step, the developed wafer needs to go through additional treatments such as annealing to consolidate the structure and enhance its properties. The entire procedure of this technique is pictorially described in Fig. 6.

4. Perovskite material development and devices for X-ray detection

Recently, different researchers have devoted their efforts to applying OIH perovskites, all-inorganic halide perovskites and lead-free halide perovskites in radiation detection besides other applications including photovoltaic applications. Generally, the direct detection and scintillation mechanism are employed for the detection of high-energy radiation and imaging application. However, herein, we only focus on the direct detection of X-rays and imaging applications. There are notable reports on perovskite-based scintillators for high-energy radiation detection, high-resolution imaging, spectroscopy and timing applications.¹¹⁶–¹¹⁸ In addition, researchers have also paid attention to a new structure named anti-perovskite structure as a radiation detector. These materials are usually developed in the form of SCs, films and wafers for radiation detection. All these forms display distinct properties. For instance, SCs display lower defects and a lack of grain boundary. Consequently, this type of crystal possesses beneficial optoelectronic properties with respect to radiation detection. Alternatively, perovskite films are compatible with flexible substrates and large-area wafers can be developed without introducing a solvent. Review Wexter on 22 February 2022. The main of the control of the contr

Therefore, in this section, we discuss some rewarding and meaningful research on perovskite-based radiation detection. Fig. 7 displays the sensitivity and LDDR of some representative works on SCs, films and wafers in OIH, all-inorganic and leadfree perovskite-based X-ray detectors. In addition, the performance of some conventional radiation detection devices is displayed in Table 1.

4.1. Organic–inorganic hybrid perovskite-based radiation detectors

Organic–inorganic hybrid perovskites display the highest efficiency in solar cell applications to date.¹²⁸ They also exhibit

Fig. 6 Isostatic-pressing method

Fig. 7 Sensitivity and lower detection dose rate (LDDR) of SC-, film- and wafer-based hybrid, all-inorganic and lead-free perovskite-based detectors.

promising optoelectronic characteristics for X-ray detection, featuring a high average atomic number, high bulk resistivity, substantial band gap ranging from 1.6 to 3.0 eV and high carrier mobility–lifetime product, typically around $\sim 10^{-2}$ cm² V⁻¹.¹²⁹ Some meaningful and representative works are tabulated in Table 2.

4.1.1. Single crystal. The sensing ability of OIH perovskite SCs was reported by B. Náfrádi and team in 2015 although the first SC perovskite-based high energy radiation detector was developed in 2013 by the renowned research group of C. C. Stoumpos by adopting an all-inorganic perovskite material.^{130,159} The research group of Náfrádi developed OIH perovskite-based $MAPbI₃$ SCs by adopting a temperaturelowering crystallization method, which were employed for detecting X-ray radiation directly.¹³⁰ They used the perovskite SC material directly as a radiation detector without using any counter electrode. They observed that the stopping power of these SCs was superior to Si-based radiation detectors. Numerically, they showed that the 110 μ m-thick MAPbI₃ SC was needed to completely stop about 30 keV soft X-rays, where a one mm-thick Si-based detector is essential. In addition, this device showed a high CCE of 75% under the irradiation of 20–35 keV Xray energy. They also investigated the device stability against Xrays and found that the photo-current decreased by less than 20% under a dose of 40 Sievert. Moreover, the humidity was responsible for the observed degradation rather than radiation because the device was not encapsulated. Finally, Monte Carlo simulations demonstrated the prospective of these SCs as radiation-shielding materials, where it was displayed that a 1 mm-thick MAPbI₃ crystal can stop 2 MeV energy radiation. One year later, in 2016, H. Wei and colleagues fabricated $MAPbBr₃$ perovskite-based SCs with a thickness of 2–3 mm for use as an

Table 2 Organic-inorganic hybrid perovskite-based X-ray detectors^ª Table 2 $\;\;\;$ Organic–inorganic hybrid perovskite-based X-ray detectors

3D and 2D materials

RSC Advances **Review Review Review Review Review Review Review Review Review**

Table 2 (Contd.)

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X-ray radiation detector by utilizing the solution growth method named anti-solvent method.³⁹ The device structure was Au/ $MAPbBr₃/C₆₀/BCP/Au$. They claimed that they limited the bulk defects by optimizing the molar ratio of PbBr₂/MABr as well as surface traps by UV-O₃ treatment. Consequently, a high $\mu\tau$ product of 1.2 \times 10⁻² cm² V⁻¹ and a small surface charge recombination velocity of 64 cm s−¹ were observed. They also found that the LDDR was as low as 0.5 μ Gy s⁻¹ together with a high sensitivity of 80 μ C Gy⁻¹ cm⁻². This sensitivity was four-
times larger than that sehiousd by using a So based Y ray reditimes larger than that achieved by using a-Se-based X-ray radiation detectors.119,120 Moreover, this device displayed 16.4% detection efficiency under continuous irradiation of X-ray energy of 50 keV without biasing. Another well-known research group, namely W. Wei et al., fabricated an Siintegrated MAPbBr₃ OIH perovskite-based SC radiation detector by adopting the method of low-temperature solutionbased molecular bonding with the help of brominated APTES molecules in 2017.¹³¹ They adopted the device structure of Au/ $BCP/C_{60}/MAPbBr₃/Si$. In addition, they used a passivating layer together with an electrode to efficiently collect the charge carriers. This detector could detect an extremely low X-rays (8 keV) with a dose rate of less than 0.1 μ Gy s⁻¹ together with high sensitivity of 2.1 × 10⁴ µC Gy⁻¹ cm⁻². This device showed 1000-
times greater sonsitivity, then that of g So based rediction times greater sensitivity than that of α -Se-based radiation detectors towards X-ray radiation. Furthermore, this device was capable of imaging with a (15–120)-fold weaker dose rate to the patient. Finally, they claimed that this detector was several degrees of magnitude better than the commercial a-Se-based Xray radiation detectors because of these performances. In 2018, F. Ye et al. developed a high-energy radiation detector by adopting two shapes of MAPbI₃ structures named d-MAPbI₃ (nonrectangular dodecahedrons) and c-MAPbI₃ (cuboid shaped) by means of the crystal growth technique ITC.¹³² The radiation detector structure was Au//Cr/MAPbI₃/Cr/Au, where they used a 1 mm-thick perovskite layer for both shapes. According to the material characterization data, they observed a lower trap density in the c-MAPbI $_3 \, (1.14 \times 10^{9} \, {\rm cm}^{-3})$ than that in the d-MAPbI $_3 \left(1.14 \times 10^{10} \, {\rm cm}^{-3} \right)$ active layer, which was even six orders of magnitude lower than that of polycrystalline-based perovskite films.^{160,161} In addition, they also measured the carrier mobility, which was found to be 293 cm 2 V $^{-1}\,{\rm s}^{-1}$ and 164 $\rm cm^2\,V^{-1}\,s^{-1}$ for c-MAPbI $_3$ and d-MAPbI $_3$, respectively. Moreover, the $\mu\tau$ product of c-MAPbI $_3$ $(3.26\times 10^{-3}~{\rm cm^2~V^{-1}})$ was greater than that of the d-MAPbI $_3 \, (1.49 \times 10^{-3}~\rm cm^2~V^{-1})$ layer. Finally, the device with c-MAPbI₃ showed better sensitivity under -1 V bias and irradiation of 50 keV high energy of X-rays. The sensitivity of the c-MAPbI₃-based device was approximately 968.9 µC Gy^{-1} cm⁻², whereas the d-MAPbI₃-based device showed a sensitivity as low as $3.4 \mu C Gy^{-1}$ cm⁻². Another group
of Y. Huang and research team daughaned three persualities of Y. Huang and research team developed three perovskitebased high-energy X-ray radiation detectors by incorporating $DMA⁺$ (dimethylammonium) and $GA⁺$ (guanidinium) in the original MAP bI_3 perovskite in 2019.¹³³ These three actual active layers named MAPbI₃, $GA_{0.16}MA_{0.84}PbI_3$ and $DMA_{0.14}MA_{0.86}PbI_3$ were developed by adopting the ITC growth technique. They used two structures named Au/perovskite/Au and Au/perovskite/ Ga by adopting symmetric electrodes and asymmetric Review Warts are entired to the light and
the symmetric decrease are all the symmetric decrease are all the symmetric intervents are all the symmetric intervents are all the symmetric intervents are all the symmetric inte

electrodes. Using asymmetric electrodes, they obtained a much lower I_{dark} for GA_{0.16}MA_{0.84}PbI₃ (4.5 nA cm⁻²) and DMA_{0.14}· $\rm MA_{0.86}PbI_{3}$ $(8.7~\rm nA~cm^{-2})$ than that of the original $\rm MAPbI_{3}$ $(21.4~\rm m)$ nA cm⁻²) SCs. In addition, they also reported that the μ t product (surface recombination velocity) of the $GA_{0.16}MA_{0.84}$ -PbI₃, DMA_{0.14}MA_{0.86}PbI₃ and MAPbI₃ structures were 1.3×10^{-2} cm 2 V $^{-1}$ (86 cm s $^{-1}$), 7.2 \times 10 $^{-3}$ cm 2 V $^{-1}$ (663 cm s $^{-1}$) and 5.3 \times 10^{-3} cm² V⁻¹ (1245 cm s⁻¹), respectively. This indicates that the structure with $\text{GA}_{0.16}\text{MA}_{0.84}\text{PbI}_3$ showed a better performance in terms of $\mu\tau$ and surface recombination velocity. Furthermore, the $GA_{0.16}MA_{0.84}PbI_3$ and $DMA_{0.14}MA_{0.86}PbI_3$ SCs showed a lower LDDR (16.9 nGy s $^{-1}$) than that of pristine MAPbI $_3$ (80.6 nGy s−¹). Finally, the highest sensitivity was also displayed by the structure with $GA_{0.16}MA_{0.84}PbI_3$ SC, which is about 2.3 \times 10⁴ $μC$ Gy⁻¹ cm⁻². Thus, by performing structural modification, v_{rev} redisting v_{rev} redis one can achieve desirable structures for detecting X-ray radiation. In 2020, Z. Fan et al. fabricated a high-crystalline $MAPbBr₃$ SC by employing the ITC method to detect ionizing radiation such as X-rays.¹³⁴ For this purpose, they used two device structures of Au/MAPbBr₃/Au and Au/MoO₃/MAPbBr₃/Ag, where the structure of $Au/MoO₃/MAPbBr₃/Ag$ showed a better performance in X-ray radiation detection. They reported that the trap density and hole mobility for the MAPbBr₃ SC were 2.26 \times 10⁹ cm^{-3} and 89.8 cm^2 V⁻¹ s⁻¹, respectively. This larger carrier mobility and low trap density of the $MAPbBr₃$ SC imply that $MAPbBr₃$ is suitable for X-ray radiation detection. They also claimed a higher carrier lifetime and larger diffusion length, which were \sim 422.85 ns and \sim 10.66 µm, respectively. Finally, they reported the device sensitivity and the lowest detectable dose of radiation, which was observed to be 1.2 µGy s⁻¹. In addition, the bighest consituity of 2552 µG Cu^{-1} am⁻² was addition, the highest sensitivity of 2552 µC Gy^{-1} cm⁻² was observed for the $Au/Moo_3/MAPbBr_3/Ag$ structure. The authors mentioned in their article that due to the insertion of $MoO₃$, the hole extraction increased, resulting in a better performance. The established research group led by Y. Liu fabricated a highquality SC of $MAPbI₃$ by adding 3-(decyldimethylammonio)propane-sulfonate inner salt as a ligand with the help of the ITC crystal growth method in 2021.¹³⁵ Due to the high crystallinity of the structure, the trap density was 7 \times 10 $^{\rm 10}$ cm $^{\rm -3}$, which was 23times smaller than that of the structure without additive. They stated that the carrier mobility and $\mu\tau$ product were improved due to the addition of the OHIS additive material in the precursor solution of perovskite. The carrier mobility and $\mu\tau$ product improved from 72 $\text{cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ to 112 $\text{cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ and 8.4×10^{-3} cm² V⁻¹ to 1.3 × 10^{-2} cm² V⁻¹, respectively. Finally, they tested the performance of this structure under X-rays of 8 keV and found the sensitivity of 2.1 × 10⁵ µC Gy⁻¹ cm⁻² with LDDR of 2.34 nGy s⁻¹. In the medical sector, high energetic Xrays typically above 60 kVp are required due to their high penetration power. Therefore, X-rays having energy levels of 60 kVp, 100 kVp, and 120 kVp were used to simulate the energy spectrum of the 2.4 mm-thick crystal in this study. The detector exhibited the highest sensitivity of 2.9 \times 10⁶ µC Gy⁻¹ cm⁻² with LDDR of 5.7 nGy s^{-1} for 60 kVp X-rays. In 2022, another research group of J. Jiang et al. synthesized three hybrid perovskite layers of MA-free named $Cs_{0.1}FA_{0.9}Pb(I_{0.9}Br_{0.1})_3$ (CsFA), $Cs_{0.1}FA_{0.85}$ - $GA_{0.05}Pb(I_{0.9}Br_{0.1})$ ₃ (CsFAGA) and CsFAGA doped with Sr²⁺

(CsFAGA:Sr) by employing ITC SC growth method.¹³⁶ Among them, the structure of CsFAGA:Sr showed a better performance for X-ray radiation detection. The incorporation of Sr^{2+} element modulated the optoelectronic features of the mother structures in favor of X-ray radiation detection. According to their report, the obtained charge mobility for the CsFA, CsFAGA and CsFA-GA:Sr structures was 162 $\rm cm^2\,V^{-1}\,s^{-1}$, 241 $\rm cm^2\,V^{-1}\,s^{-1}$ and 288 $\rm cm^2~V^{-1}~s^{-1},$ respectively. A higher lifetime was also observed for the CsFAGA:Sr structure, which was 1059 ns. The $\mu\tau$ product and surface recombination velocity of the structure were also improved with respect to the other structures, which were 1.29 \times 10⁻² cm² V⁻¹ and 82 cm s⁻¹, respectively. In addition, promising sensitivity was also observed for the CsFAGA:Sr device under 1 V $\rm cm^{-1}$, which exhibited the highest sensitivity of 2.7 \times 10⁴ μC Gy⁻¹ cm⁻², which was almost 33- and 2-times
larger than that of the CeEA and CeEACA structures at a dece larger than that of the CsFA and CsFAGA structures at a dose rate of 155 nGy s^{-1} , respectively. Moreover, they obtained a stable sensitivity of \sim 2.6 × 10⁴ μC Gy⁻¹ cm⁻² for the CsFA-GA:Sr structures under different dose rates (18–940 nGy $\rm s^{-1}$). However, the LDDR of 7.09 nGy s^{-1} was the lowest among the structures. In 2023, the prominent research group led by Q. Xu and colleagues fabricated an $MAPbBr₃ SC$ by utilizing a continuous solution growth technique to signicantly decrease the formation of defects produced by the repetitive ITC technique.¹³⁷ The device structure and dimensions were Au/ MAPbBr₃/Au and $(40 \times 40 \times 2)$ mm³, respectively. They found a trap density as low as \sim 8.22 × 10⁸ cm⁻³ and high $\mu\tau$ product of 3.3 \times 10 $^{-3}$ cm 2 V $^{-1}$. In addition, they also conducted studies on the sensitivity and LDDR. The highest X-ray sensitivity of 2.35 × 10^5 µC Gy⁻¹ cm⁻² and LDDR of 15.7 nGy s⁻¹ were recorded. They also performed a stability test by preserving the device in air with 60% humidity and 25 °C temperature. They had found that I_{dark} increased significantly after 7 days. Alternatively, the device in an Ar-filled glove box displayed no change in I_{dark} and photo-current after more than 100 days. Moreover, they developed a pixeled perovskite photoconductor system for imaging applications. The bottom and top electrodes of the device were constructed using a thin Au coating that was thermally evaporated. Then, they recorded the X-ray image of a hex nut with this direct-conversion pixelated device. The pulsed Xray source (ULTRA 12040Hf Portable X-ray source) had a pulse length of 4 s and energy of 70 keV. The greatest photo-current to I_{dark} ratio was 23.8 at a low dosage rate of 0.45 Gy s⁻¹ and an applied electric field of 20 V mm $^{-1}$. The X-ray image of the hex nut was developed by employing the photo-current to I_{dark} ratio in each pixel. The spatial resolution was limited by the huge size of the pixels, resulting in a high-contrast picture. Thus, by optimizing the synthesis process, a highly efficient device could be attained. Fig. 8 depicts the crystallization technique, characterization, X-ray detection and imaging. RSC Advances **Examples** (CarAxAsty by employing ITE SC growth method."" Among cosing solutions, where they need the common polar solverness are considered to the article in the second of the second of the second of the se

4.1.2. Thin/thick film. Perovskite film developing processes are well-established compared to SC growth techniques in the case of solar cell fabrication. Recently, several research groups have been exploring the application of perovskite films in the field high-energy radiation detection. In 2015, for the first time, the research group of S. Yakunin developed a hybrid perovskite film with a large size (more than 250 nm) by adopting spray-

coating solutions, where they used the common polar solvent DMF to dissolve MAPbI₃.¹⁴⁰ High crystallinity and large grain size are essential for efficient charge transportation. They observed a lower mobility–lifetime product of 2 \times 10⁻⁷ cm² V⁻¹. Similarly, they also calculated the mobility and photoluminescence–lifetime, ranging from 4×10^{-7} cm² V⁻¹ to 1.3 \times 10^{-6} cm² V⁻¹, which is much lower than that of SC-based radiation detectors. This reveals that high crystallinity and large grain size were not achieved for smooth charge transportation. They also investigated the sensitivity of the film under X-ray radiation. The observed sensitivity and responsivity were 25 µC mGy⁻¹ cm⁻³ and 1.9 × 10⁴ carriers/photon under 37 keV X-ray energy, respectively. One year later, in 2016, C. Chen and research group fabricated a device using a hybrid perovskite film such as $MAPbI₃$ by adopting the spin-coating technique.¹⁴¹ In this device, they used the common solar cell structure. Particularly, they utilized a hole transport and electron transport layer for efficiently collecting the charge carriers. The overall device structure was ITO/PEDOT:PSS/MAPbI₃/ PCBM/Al. They observed the behavior of the device upon exposure to X-ray irradiation and without X-ray irradiation. They found that the I_{dark} of the device was as low as 2 nA, which was amplified up to 25 nA when the device was exposed to X-ray radiation. In addition, they claimed that the responsivity of their was 12.5 A W^{-1} . Moreover, it has been established that although the performance especially the sensitivity of radiation detectors increases with the biasing voltage, it initiates background noise. In 2017, another well-known research group of Y. C. Kim fabricated a film for application in X-ray detectors by using polycrystalline $MAPbI₃$, which was printed on a thin-film transistor backplane.¹⁴² They utilized a two-step solvothermal technique including α -terpineol to develop MAPbI_{3.} Finally, they obtained a dense and viscous mixture, which was printed by employing the doctor blade method. The $\mu\tau$ product of the film was observed to be large with a value of 1×10^{-4} cm² V⁻¹. In addition, the sensitivity of the device was observed to vary from 1 to 11 μ C mGy⁻¹ cm⁻² with a change in the electric field from 0.01 to 0.24 V μ m⁻¹. Two years later, in 2019, L. Basirico^o
and recearch team supplement was X rew rediction detectors and research team synthesized two X-ray radiation detectors with the help of adopting two hybrid perovskite materials including $Cs_{0.05}FA_{0.79}MA_{0.16}Pb(I_{0.8}Br_{0.2})_3$ and MAPbI₃ using the standard anti-solvent technique, where chlorobenzene was used as the anti-solvent.¹⁴³ In this device architecture, a mesoporous electron transport layer together with a compact transport layer were utilized for elevating the interfacial band alignment with the perovskite material for efficient charge carrier collection. The structure of the device was $FTO/c-TiO_2/m-TiO_2/perovskite/$ Spiro-OMeTAD/Au. They reported that the $\mu\tau$ product was double for the Cs_{0.05}FA_{0.79}MA_{0.16}Pb(I_{0.8}Br_{0.2})₃ structure (∼2.0 × 10^{-5} cm² V⁻¹) compared to that of MAPbI₃ (~1.0 × 10⁻⁵ cm² $\rm V^{-1}$). A similar pattern was also observed in the sensitivity of the structures. They claimed that they attained a self-powered radiation detector using this perovskite-based film. The sensitivity for the structure based on $CS_{0.05}FA_{0.79}MA_{0.16}Pb(I_{0.8}Br_{0.2})_3$ was of ~3.7 μC Gy^{-1} cm⁻² under no biasing. However, under a reverse bias of 0.4 V, the sensitivity of the structure increased to 97 μC Gy⁻¹ cm⁻² despite it being a film, which exceeds the

Fig. 8 (a–c) Continuous solution growth technique; (d–f) images of MAPbBr₃ SCs; and (g) I_{dark} curve for the device. (h) Current trace of the device across a bias range; (i) device current response to pulsed X-ray at various biases; (j) current response at various dose rates; (k) temporal photocurrent response for vertical surface detector; (l) schematic illustration of the imaging detector; (m) image of a hex nut on top of pixelated MAPbBr₃ X-ray detector; and (n) X-ray image of the hex nut based on the ratio of photo-current (X-ray induced) to I_{dark} . Reprinted with permission from ref. 137. Copyright 2023 Elsevier B.V.

values of sensitivity of the commercially available detectors such as poly-CZT and α -Se.^{119,120,124} In 2020, the research group of X. Liu et al. fabricated a hybrid perovskite-based X-ray

radiation detector via the compositional engineering of MAPbI_{3-x}Cl_x through the spin-coating process.¹⁴⁴ The structure of the detector was Ag/RhB101–LiF/PCBM/MAPbI_{3-x}Cl_x/

PEDOT:PSS/ITO. They investigated the properties to justify the efficiency of device to detect high-energy radiation under 70 keV X-ray energy. They claimed that the sensitivity of their device was up to 67 μ C Gy⁻¹ cm⁻², which is better than some traditional X-roy detectors. It was also revealed that an appropriate tional X-ray detectors. It was also revealed that an appropriate charge carrier transport layer and compositional engineering can help realize a relatively better radiation-detecting device. In addition, they also reported the lower detection ability of the device, which was about 0.2 mGy $\rm s^{-1}.$ The established research group led by X. Xu fabricated an X-ray detection device by employing a 2D-3D double-layer perovskite film, where they utilized $(PEA)_{2}MA_{3}Pb_{4}I_{13}$ as the 2D layer and MAPbI₃ as the 3D layer in the structure of FTO/2D–3D/carbon with help of the sequential deposition method in 2021.¹⁴⁵ They claimed that the resistivity of the double-layer film increased from 3.5 \times 10⁸ Ω cm to 3 \times 10⁹ Ω cm due to the insertion of the 2D perovskite layer. They also reported the $\mu\tau$ product was 2.2 \times 10 $^{-5}$ cm 2 V $^{-1}$. Consequently, this 2D–3D double-layered device displayed a high sensitivity of $1.95 \times 10^4 \mu C Gy^{-1}$ cm⁻² as well as an LDDR of 480 nGy s $^{-1}$. Thus, this is another strategy for the fabrication of efficient detectors by combining low-dimensional materials with 3D materials. In 2022, another research team consisting of Y. Xiao and colleagues synthesized a hybrid perovskite-based Xray radiation detector by employing a 2D material embedded with a 3D material, where they utilized $BA₂PbI₄$ as the 2D material and $MAPbI₃$ as the 3D material.¹⁴⁶ The structure of the detector was Au/BA₂PbI₄-MAPbI₃/Au. Their analysis reported that the ion migration and I_{dark} were reduced significantly due to the presence of the 2D material in the structure and the obtained I_{dark} drift was 4.84×10^{-5} nA cm⁻¹ s⁻¹ V⁻¹. They also confirmed the performance of the device, where the X-ray sensitivity of this bulk 2D/3D heterostructure-based detector was $2.0 \times 10^3 \mu C$ Gy⁻¹cm⁻² and the lower detection limit was
also as low as 111.75 pCy s⁻¹ under bissing of 10 V. In 2022, the also as low as 111.76 nGy s⁻¹ under biasing of 10 V. In 2023, the prominent research group of W. G. Li et al. fabricated a device based on an $MA_{0.42}FA_{0.58}PbI₃$ film with the help of ultrasoundassisted crystallization with post hot-pressing technique.¹⁴⁷ This film growth technique offers homogeneous nucleation, large grain size, less defects, and quasi-monocrystalline film. After the post-hot-pressing curing, the carrier mobility and $\mu\tau$ product improved from 1.8 $\mathrm{cm}^2\,\mathrm{s}^{-1}\,\mathrm{V}^{-1}$ to 23.5 $\mathrm{cm}^2\,\mathrm{s}^{-1}\,\mathrm{V}^{-1}$ and from 8.4 \times 10 $^{-6}$ cm 2 V $^{-1}$ to 1.5 \times 10 $^{-4}$ cm 2 V $^{-1},$ respectively. Accordingly, an efficient $MA_{0.42}FA_{0.58}PbI_3$ quasimonocrystalline-based X-ray detection device was accomplished with remarkably high sensitivity of 1.16 \times 10⁶ µC Gy⁻¹ cm^{-2} and LDDR of 37.4 nGy s⁻¹. In 2023, another eminent researcher J. Zhao and colleagues synthesized an X-raydetecting device, which was also employed to image an object.¹⁵⁰ They achieved a successful device by fabricating an $MAPbI₃$ active film utilizing the spray-coating method. They adopted a strategy to make a more efficient layer by incorporating Bi^{3+} . They claimed that their 5% Bi^{3+} -doped layer lowered the I_{dark} by an order of magnitude compared to the pristine film. The device structure was ITO/n-MAPbI₃/p-MAPbI₃/Au, where pristine MAPbI₃ displayed weak p-type characteristics, and n-MAPbI₃ indicated 5% Bi^{3+} doping in MAPbI₃. The device was confirmed to exhibit a high sensitivity of 1969.75 µC Gy⁻¹ cm⁻² **PSC** Advances **CONDISTING**. The investigated the properties to justify the and LDDR of 137.65/₂². In addition, the device childrensed on the properties are the second of the article is licensed in the second of the s

and LDDR of 147 nGy s^{-1} . In addition, the device exhibited outstanding flexibility and durability, where it sustained a high performance after being bent 2000 times or kept at 30-50% RH under environmental conditions for more than a month. For the imaging, they fabricated a flexible X-ray detector with a size of 100 cm^2 and verified the homogeneity of the device by measuring the dark and X-ray illumination response currents of a chosen 5 \times 5 pixel array. Each pixel was 4 mm² in size and 1 mm at a distance. The dark and X-ray illumination response currents were estimated to be 267–294 nA and 470–510 nA, respectively. The spatial resolution of the device was about 3.3 lp mm^{-1} in the flat state and 3.1 lp mm^{-1} in the bent state. The X-ray images of the letters SEU were recorded in the flat state and bent state, where the letters were clearer for the bent detector than the flat detector. They also took another image of a piece of ham with a nail inside to simulate human body injury, where the hole and nail inside the ham were observed in the Xray image. Ultimately, they demonstrated the potential of the device in X-ray detection and imaging applications. The entire procedure of film development, characterization, X-ray detection and imaging is depicted in Fig. 9.

4.1.3. Wafers. Perovskite materials in the form of wafers offer a favorable and simplistic route for scaled-up applications including large and wearable flat panels, making them superior to other types of perovskite-based radiation detectors.¹⁶² A perovskite wafer, when fabricated without the introduction of a solution, realizes almost 100% utilization of materials because it directly transforms the initial precursor materials into the desired perovskite structure. In this section, we focus on the optoelectronic properties and performance of wafers for radiation detection. In 2016, Y. Liu and research team developed a wafer of MAPbI₃ for radiation detection by employing an ultrathin geometry-defined dynamic-flow reaction scheme.¹⁵² The structure of the device was $Au/MAPbI_3/Au$. After the fabrication of the device, they basically investigated the optoelectronic properties for radiation detection. They reported a low trap density of 6 \times 10⁸ cm⁻³, which is extremely low in comparison with the previously reported data, and the carrier mobility was 39.6 cm² V⁻¹ s⁻¹. Their radiation detector was more responsive towards radiation than that of a microcrystal thin film.¹⁵² Particularly, they observed 350-times greater responsivity for the MAPbI₃ SC wafer than a thin film under irradiation of 100 mW cm^{-2} with biasing of 2 V. As part of another initiative in 2017, the research group of S. Shrestha created a series of wafers by using the hybrid perovskite material MAPbI₃ adopting a room-temperature sintering technique.¹⁵³ The size of the wafer was half-inch in diameter and 200 mm to 1 mm in thickness. In addition, the density of the wafer was 3.76 $\rm g$ cm $^{-3}$, which is close to the density of the MAPbI₃ SC (4.15 g cm−³).163,164 Moreover, they have reported the ambipolar μ τ product with a value of 2 \times 10 $^{-4}$ cm 2 V $^{-1}$. Consequently, they found the excellent sensitivity of 2527 µC Gy^{-1} cm⁻² under 70 kVp X-ray irradiation with a 0.2 V μ m⁻¹ electric field. Two years later, in 2019, J. Gao and colleagues fabricated a wafer-based radiation detector with the help of $MAPbI₃$ by utilizing the combination of the space-confined technique with seedinduced crystallization process.¹⁵⁴ Their developed wafers were

Fig. 9 (a) Cross-sectional SEM images of the Bi-doped MAPbI₃ film; (b) cross-sectional SEM images of the p–n junction; (c) XRD outlining of the original p-MAPbI₃ layer, and Bi-doped n-MAPbI₃ layer; (d) dark I–V curves of the device with different Bi³⁺ concentrations; (e) X-ray (40 kV) sensitivity and I_{dark} with respect to different Bi³⁺ concentrations at a biasing voltage 1 V; (f) absorption spectra of the n-MAPbI₃ and p-MAPbI₃ layers and curves of ($\alpha h\nu$)² versus photon energy (inset); (g) snapshot of the bent X-ray detector (the bending radius is indicated by the red line in the circle); (h) sensitivity versus biasing voltage under illumination with a 40 kV X-ray source; (i) I–V curves attained under different bending radii; (j) I-T curves and (k) photo-current versus dose rate at 1 V under altering bending radii with respect to different dose rates; (l) sensitivity of the device under flat circumstances after 2000 bends with a 5 mm bending radius; (m) experimental X-ray imaging setup (schematic) during planar and curve X-ray imaging; (n) planar in top and curved in bottom X-ray imaging showing the "SEU" symbol; (o) real object of a ham with a nail and (p) X-ray images of a piece of ham with a nail inside. Reprinted with permission from ref. 150. Copyright 2023 @ The Royal Society of Chemistry.

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as large as 10 mm without grain boundaries. The structure of the device was $Au/MAPbI₃/Au$. This radiation detector with outstanding crystal quality demonstrated remarkable performance features. They also claimed that they achieved a lower trap density of 2.36 \times 10 $^{\rm 10}$ cm $^{\rm -3}$, which was lower than that of polycrystalline thin films. In addition, the device displayed a light on/off current ratio of 4.3×10^3 , response time of 770 μ s,
and linear dynamic range of 110 decibels. Moreover, even at and linear dynamic range of 119 decibels. Moreover, even at very low irradiation levels of 80 nW cm−² , this device demonstrated an exceptional external quantum efficiency of 904%, responsivity of 3.87 A W^{-1} , and detectivity of 1.77 \times 10 13 Jones. Furthermore, they also investigated the stability issue and found more than 80% of the initial photo-current was maintained after 30 days of air storage. The research group comprised of M. Hu and colleagues fabricated an X-ray radiation detection device with the help of an $MAPbI₃$ wafer in 2020.¹⁵⁵ They utilized a one-step heat-assisted high-pressure pressing scheme, which enabled the fabrication of large-size wafers. The carrier mobility of the attained wafer was ∼20 cm² V⁻¹ s⁻¹. Accordingly, the $\mu\tau$ product was as high as 3.84 \times 10^{-4} cm² V⁻¹. For the purpose of performance evaluation, the adopted structure of their device was Au/PCBM/MAPbI₃/Au. When subjected to an X-ray source with an acceleration voltage of 40 kV, the detector displayed an outstanding X-ray sensitivity as high as $1.22 \times 10^5 \mu C Gy^{-1}$ cm⁻² under a biasing voltage of 10 V. This approach provides a convenient technique for developing sizable perovskite wafers with favorable optoelectronic properties for radiation detection. In 2021, S. Deumel and team adopted a two-step fabricating system for the formation of an X-ray flat-panel detector by employing MAPbI₃ based on the mechanical sintering of an independent absorber layer and the subsequent incorporation of this layer onto a pixelated backplane.¹⁵⁶ The wafer, which was made of freestanding microcrystalline MAPbI₃, demonstrated sensitivity of 9300 μ C Gy $^{-1}$ cm $^{-2}$ together with a μ τ product of 4 \times 10 $^{-4}$ cm 2 V $^{-1}$. The resulting X-ray imaging device, featuring 508 pixels per inch, attained an inspiring combination of high spatial resolution at six line pairs per millimeter and an LDDR of 0.22 nGy $^{-1}$ per frame. In 2022, the prominent research group of L. Liu et al. developed a device for X-ray detection by adopting a novel direct-indirect hybrid perovskite wafer with the help of a fasttableting process.¹⁵⁷ The device structure was Au/Spiro–OMe-TAD/MAPbI₃/MAPbI₃-Cs₃Cu₂I₅/MAPbI₃/C₆₀/BCP/Cr. Because of the fast energy transfer from $Cs_3Cu_2I_5$ to MAPbI₃, the device response time towards X-rays was signicantly reduced by almost 30-fold, resulting in a rapid detection capability for a large-area detector array in under 1 s. In addition, the reported resistivity value of the 30% Cs₃Cu₂I₅ wafer was 5.4 \times 10⁷ Ω cm, which was 1.21-times higher than that of the $MAPbI₃$ wafer. They also revealed that the sensitivity of the device regularly decreased with an increase in the content of $Cs₃Cu₂I₅$. The device with 30% of $Cs₃Cu₂I₅$ had the lowest detection dose rate of 0.41 μ Gy s⁻¹, which was much lower than the real dose rate of 5.5 μGy s^{-1} throughout CT imaging. In addition, this value was also 1.5-times and 10-times lower than that of the direct-type $MAPbI₃$ semiconductor and the $Cs₃Cu₂I₅$ scintillator, respectively.¹⁶⁵ Finally, the sensitivity of this hybrid X-ray detector was RSC Advances Articles. The structure of contained on 22 February 2022. The structure of the structure of the main of the structure of th

enhanced by 28 times in comparison with the indirect-type scintillator. Very recently, in 2023, the well-established research group led by W. Liu prepared a high-crystalline $MAPbI₃$ -based perovskite wafer with the help of $PbI₂$ -DMSO powder as an additive for X-ray detection.¹⁵⁸ The white $PbI₂$ -DMSO powders were obtained by annealing a complex solution PbI2–DMSO, where DMSO was vaporized during annealing. During the process of isostatic pressing, a mixture of $PbI₂$ $DMSO$, MAI, and $MAPbI₃$ was combined and compressed on the perovskite wafer. At a relatively lower annealing temperature, the release of DMSO as vapor from PbI_2 –DMSO led to the spontaneous growth of crystals within the perovskite wafer. This provided a route for increasing the grain size, together with the passivation of grain boundaries as well as reducing the defect densities. Consequently, a dense and compact $MAPbI₃$ wafer was obtained with a lower trap density of 1.22 \times 10¹⁰ cm^{-3} and greater carrier mobility of 3.5 cm^2 V⁻¹ s⁻¹ with respect to the traditional device (1.63 \times 10¹⁰ cm⁻³ and 1.3 cm² $\rm V^{-1}$ s $^{-1},$ respectively). 158 In addition, the device displayed a high μ τ product with a value of 8.70 \times 10 $^{-4}$ cm 2 V $^{-1}$. Moreover, they claimed that the higher sensitivity and LDDR were 1.58 \times 10⁴ μ C Gy⁻¹ cm⁻² and 410 nGy s⁻¹, respectively. They also per-
formed the imaging test of the device by taking an image of formed the imaging test of the device by taking an image of a memory card consisting of a plastic case and metal core. They successfully obtained a clear image of the memory card using this device. Thus, this study demonstrated an efficient strategy for perovskite wafer-based devices for X-ray radiation detection and imaging. The wafer development, characterization, X-ray detection and imaging are depicted in Fig. 10.

4.2. All-inorganic halide perovskite detectors

Although X-ray radiation detectors based on OIH perovskites have exhibited a noteworthy performance, the stability of these hybrid materials is lacking. Specifically, their extreme sensitivity towards light, heat, oxygen and moisture are the reasons for this low stability.¹⁶⁶ All-inorganic perovskites are expected to be the future X-ray detecting materials owing to their comparatively better stability than hybrid perovskites. Some representative works are presented in Table 3.

4.2.1. Single crystals. In 2013, the well-known research group of C. C. Stoumpos and colleagues developed an SC ingot of CsPbBr₃ with a diameter of 7 mm and thickness of 2.1 mm by adopting the vertical Bridgman technique for radiation detection.¹⁶⁷ They reported that their structure possessed a high carrier mobility and $\mu\tau$ product, which were detected to be 1000 cm² V⁻¹ s⁻¹ and 1.7 × 10⁻³ cm² V⁻¹, respectively. In addition, they also reported that their structure attained a resistivity as high as 3.43 \times 10¹¹ Ω cm, which is essential to inhibit I_{dark} . Actually, these properties are essential for X-ray radiation sensing and imaging. They also investigated the suitability of the material as a detector by utilizing Ag as the X-ray source with the energy of 21.59 keV. The structure could distinguish the K_{α} and K_{β} peaks. However, the sensitivity of the response was approximately 1% of that of the standard CZT detector. After a few years, in 2017, the research group of W. Pan fabricated a high-crystalline $Cs_2AgBiBr_6$ SC by employing the popular ITC

Fig. 10 (a) Schematic illustration of preparation of PbI₂–DMSO-assisted isostatic pressing of MAPbI₃ wafer; (b) SEM images (top view); (c) SEM images (cross-sectional); (d) AFM images; (e) photoconductivity; (f) resistivity; (g) J–V characteristics; (h and i) PbI₂–DMSO-assisted MAPbI₃ device: current densities versus function of dose rate at different electric fields; (j) dose rate dependent SNR of the device; (k) photograph of a memory card and (l) X-ray image of the memory card. Reprinted with permission from ref. 158. Copyright 2023 @ Wiley Online Library.

method for the detection of X-rays.¹⁶⁸ They made a symmetric device utilizing the structure of $Au/Cs_2AgBiBr_6/Au$. They extensively investigated and compared the carrier transportation properties with other reported studies. They observed the trap density as low as 1.74×10^{9} cm⁻³ and carrier mobility as high as 11.81 cm² V⁻¹ s⁻¹. Subsequently, the $\mu\tau$ was observed to be 6.3 \times 10^{-3} $\rm cm^2$ $\rm V^{-1},$ which is comparable to that of MAPbBr₃ (1.4 \times $10^{-2}\,\mathrm{cm^2\,V^{-1}}$), MAPbI $_3$ $(1.0\times10^{-2}\,\mathrm{cm^2\,V^{-1}})$ and the best-quality CdZnTe SCs $(9.1 \times 10^{-3} \text{ cm}^2 \text{ V}^{-1})$. They also reported the highest resistivity of 1.60 \times 10¹¹ Q cm. This higher resistivity is

the reason for the lower background current, and accordingly lower noise current. They evaluated the performance of the device under a tungsten anode X-ray tube with X-ray photon energy of up to 50 keV and peak intensity at 30 keV. The device displayed a good sensitivity of 105 µC Gy⁻¹ cm⁻² and LDDR of 59.7 nGy s^{-1} . In 2018, as another initiative, the research team of J. A. Steele and colleagues synthesized a device with the structure of $Au/Cs₂AgBiBr₆/Au$ for radiation detection under different temperature conditions.¹⁶⁹ They observed a poorer performance at room temperature than that at liquid- N_2 temperature due to

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Table 3

Table 3 All-inorganic perovskite-based X-ray detectors

All-inorganic perovskite-based X-ray detectors^a

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Various layers (ETL, HTL, interfacial layer, electrodes) applied to pre-existing perovskite layers using standard techniques such as thermal evaporation, sputtering, spin coating, shadow mask

application, and high vacuum deposition.

the poor charge carrier dynamics. After reducing the temperature from room temperature to liquid-nitrogen for the $Cs₂$ - $AgBiBr₆$ structure, they observed a substantial improvement in the charge carrier life time from 700 ns to 1500 ns, which indicates the huge reduction in the negative impact of both parasitic recombination paths and I_{dark} . Subsequently, the sensitivity of the device was enhanced from 316 μ C Gy⁻¹ cm⁻² at room temperature to 988 µC Gy⁻¹ cm⁻² at liquid-N₂ temperature. One year later, in 2019, W. Yuan et al. prepared two devices for X-ray radiation detection utilizing pristine $Cs₂AgBiBr₆$ and PEA–Cs₂AgBiBr₆ SCs with the structure of Au/perovskite/Au.¹⁷⁰ They reported the trap density of 6.04 \times 10⁹ cm⁻³ and 3.43 \times 10^9 cm⁻³ for the structure of Cs₂AgBiBr₆ and PEA–Cs₂AgBiBr₆, respectively. In addition, the observed carrier mobility of the pristine Cs₂AgBiBr₆ and PEA–Cs₂AgBiBr₆ SCs was 2.25 cm² V⁻¹ $\rm s^{-1}$ and 55.7 $\rm cm^2$ V $^{-1}$ $\rm s^{-1}$, respectively. Moreover, the $\mu\tau$ product of Cs₂AgBiBr₆ and PEA–Cs₂AgBiBr₆ was observed to be 9.14 \times 10^{-4} cm 2 V $^{-1}$ and 1.94 \times 10^{-3} cm 2 V $^{-1}$, respectively. According to these results, the best sensitivity of these two devices was found to be 165.6 µC Gy^{-1} cm⁻² and 288.8 µC Gy^{-1} cm⁻² under a field of 22.7 V mm $^{-1}$, respectively. Another research group led by Z. Fan synthesized two radiation detection devices by adopting CsPbBr₃ SCs without and with an $MoO₃ HTL$ by means of the anti-solvent crystallization process in 2020.¹⁷¹ The structures were Au/perovskite/Au and Au/perovskite/MoO₃/Au. The trap density and mobility of the carrier were observed to be 3.87 \times 10¹⁰ cm³ and 10.7 cm² V⁻¹ s⁻¹, respectively. In addition, the average lifetime of the carrier was (6.25 ± 1.06) ns. Moreover, they investigated the sensitivity of these two structures under a 50 kV tungsten anode X-ray tube. They observed the highest sensitivity in the case of the structure of Au/perovskite/MoO₃/Au compared to that of Au/perovskite/Au. Particularly, the observed values for the structures with $MoO₃$ and without $MoO₃$ were 619 μC Gy⁻¹ cm⁻² and 200 μC Gy⁻¹ cm⁻² under an electric field of 45 V cm $^{-1}$, respectively. Basically, this can be attributed to the increase in hole carrier collection by the HTL. In 2021, J. Peng et al. fabricated two devices for X-ray detection with $CsPbBr₃SC$ developed in DMSO and CsPbBr₃ SC developed in water.¹⁷² The SC grown in DMSO was fabricated by adopting modified ITC, while an SC was grown in water by gradually reducing the temperature of the water solution. The device structures were $ITO/NiO_x/poly-TPD/perovskite/C_{70}/BCP/Cu.$ Here, they employed a charge carrier transporting and passivating layer for making the band alignment with the perovskite layer convenient. They observed a better performance in the case of the structure developed in water. Specifically, the mobility for holes and electrons in CsPbBr₃ developed in water was 128 cm² V⁻¹ $\rm s^{-1}$ and 160 cm² V⁻¹ s⁻¹, whereas it was 12.8 cm² V⁻¹ s⁻¹ and 28.5 $\rm cm^2$ V $^{-1}$ s $^{-1}$ for CsPbBr₃ synthesized in DMSO, respectively. The devices performance was estimated under the spectrum of X-rays from a tungsten anode tube functioning at 60 kVp. They claimed that the device grown in water displayed a high sensitivity of 4086 µC Gy⁻¹ cm⁻² towards X-rays, which is almost 200times superior to that of commercial α -Se detectors (20 µC Gy⁻¹ cm−²).¹⁷² In 2022, the prominent research group consisting of P. Zhang and colleagues fabricated a device with a $CsPbBr_{3-n}I_nSC$ by incorporating iodine into pristine CsPbBr₃.¹⁷³ The structure Review Web article control in the control in the component of the device was duel arbitraries and the measure of the component with the strength of the component with the strength of the component with the strength of the

of the device was Au/CsPbBr_{3−n}I_n/Au. They reported a higher resistivity for the structure with iodine in comparison with the pristine structure, with values of 3.6 \times 10⁹ Ω cm (pristine CsPbBr₃) and 2.2 \times 10¹¹ Ω cm (CsPbBr₂I). They also performed a sensitivity test under 120 keV hard X-rays with an electric field of 5000 V cm⁻¹. The champion sensitivity of 6.3 \times 10⁴ μC Gy⁻¹
cm⁻² was observed for the device with the CsPbPr J_n SC and cm^{-2} was observed for the device with the CsPbBr_{2.9}I_{0.1} SC and an LDDR of 54 nGy s^{-1} was obtained for the detector with $CsPbBr₂I$ SC. Thus, the incorporation of foreign atoms or doping strategy can be adopted to enhance the optoelectronic features of the devices. Recently, in 2023, the established research team led by Y. Hua fabricated a radiation detector with a CsPbBr₃ SC by utilizing a homemade dual-temperature zone vertical Bridgman furnace.¹⁷⁴ The temperature of the upper zone and lower zone of the furnace was approximately 640 °C and 300 °C, respectively. The structure of the device was GaIn/ $CsPbBr₃/Au$. They investigated the performance of the device and found anisotropic behavior along the [100], [010], and [001] orientations of the bulk $CsPbBr₃$ SC. Among the orientations, the (010) surface of the structure displayed a better performance in terms of reducing defects and enhancing the carrier transportation due to the specific arrangement of positive and negative charge distribution and the connection between the $[DbBr_6]^{4-}$ octahedrons. Furthermore, the (010)-oriented crystal exhibited the lowest ion migration owing to its high active energy (143.77 meV) and ion diffusion barrier (0.361 eV), making it a favorable choice for improving the X-ray response. The device with the (010) orientation demonstrated the champion sensitivity of 34 449 µC Gy⁻¹ cm⁻² under a biasing of -400 V and the LDDR of 52.6 nGy s⁻¹ in comparison with the other two orientations. The entire procedure of the crystal development technique, characterization, and X-ray detection is depicted in Fig. 11.

4.2.2. Thin/thick films. In 2018, the eminent research group led by Y. Xu fabricated a device for the direct conversion of X-ray photons to current by utilizing an all-inorganic perovskite film.¹⁷⁶ The film was developed with the help of a one-step coating technique (E-spraying procedure). The device structure was FTO/c-&m-TiO₂ + Cs₂TeI₆/PTAA/Au. Their extensive investigation revealed that the film resistivity was 4.2 \times 10¹⁰ Ω cm and the electron drift-length was 200 µm under 400 V cm⁻¹. In addition, the *us* product for electrons was assessed to be 5.2 \times addition, the $\mu\tau$ product for electrons was assessed to be 5.2 \times 10^{-5} cm² V⁻¹. Furthermore, the sensitivity test of the device was accomplished under the irradiation from an Ag X-ray cathode with photon energy of 40 kVp. The sensitivity of 19.2 μ C Gy⁻¹ cm^{-2} was observed under an electric field of 250 V cm^{-1} . Another research group of W. Pan et al. fabricated an inorganic perovskite $CsPbBr₃$ film via the hot-pressing method for the detection of X-ray photons.¹⁷⁷ The structure of the detector was FTO/perovskite/Au. The carrier mobility for the film of a gradually cooled perovskite film was greater (average 70 cm² V⁻¹ s⁻¹) than that of the faster cooled perovskite film (12.3 cm 2 V $^{-1}$ s $^{-1}$). Consequently, the $\mu\tau$ was better (1.32 × 10⁻² cm² V⁻¹) for the slowly cooled perovskite film than the faster cooled perovskite film (5.12 \times 10⁻³ cm² V⁻¹). This was attributed to the formation of less defects during the slow cooling process. For the evaluation of the device performance, it was exposed to a tungsten

Fig. 11 (a) Schematic diagram of the vertical Bridgman furnace. (b) Photograph of an as-grown CsPbBr₃ SCs. (c) XRD patterns of the (100), (010), and (001) facets of processed and polished wafers. (d–f) Photo-current fitting curves of the [100], [010], and [001] facets, respectively. (g) Photocurrent response versus dose rates at [−]400 V. (h and i) X-ray sensitivities of the (100), (010), and (001) facet devices under various voltages. (j) Comparison of I_{dark} drifts for the (100), (010), and (001) facet devices under a biasing voltage of −10 V. (k-m) Responses and SNR values dependent on the dose rate from 135 nGy s⁻¹ to 260 nGy s⁻¹ for the (100), (010), and (001) facet devices, respectively. (n) Detection limits (derived from the fitting line with an SNR of 3). Reprinted with permission from ref. 174. Copyright 2023@ The Royal Society of Chemistry.

anode X-ray source with a photon energy of 50 keV. The champion performance was recorded to be 55 684 µC Gy^{-1} cm⁻² under the applied electric field of 5 V $\mathrm{mm}^{-1}.$ One year later, in 2020, G. J. Matt and research team developed a device for X-ray detection by adopting $CsPbBr₃$ as an active layer.¹⁷⁸ The film of $CsPbBr₃$ with a thickness of 100 μ m was obtained by a scalable melt process. The structure of the detector was Ga/perovskite/ FTO. The attained resistivity and hole mobility were 8.5 \times 10⁹ Ω cm and 18 cm² V⁻¹ s⁻¹, respectively. The performance of the device was total updated by Ω in Ω we source operating at 70 kgM device was tested under an X-ray source operating at 70 keV filtered with 2 mm Al. The sensitivity of the device was estimated to be 1450 μ C Gy⁻¹ cm⁻² under a biasing electric field of 1.2×10^4 V cm⁻¹ and the LDDR was around 500 nGy s⁻¹. In 2021, the prominent research group of W. Qian fabricated a CsPbI₂Br film having an area of 100 cm² through an aerosolliquid–solid approach.¹⁷⁹ The structure of the detection device was carbon/perovskite/FTO. The trap density and electron mobility of the CsPbI₂Br films were about 6.71 \times 10^{13} $\rm cm^{-3}$ and 1.14 cm² V⁻¹ s⁻¹, respectively. The traps density was relatively high in this film compared to other type of structures. However, the attained sensitivity of the device was as high as 1.48×10^5 μ C Gy⁻¹ cm⁻² and the LDDR was 280 nGy s⁻¹ under the biasing of 0.125 V mm⁻¹ electric field. One year later, in 2022, P. T. Lai et al. synthesized a highly sensitive CsPbI₂Br film with different thicknesses by employing the vacuum-deposition technique.¹⁸⁰ The device structure was $\text{ITO/Ca/C}_{60}/\text{CsPbI}_2\text{Br}/4,4'\text{-cyclo-}$ hexylidenebis[N,N-bis(4-methylphenyl)benzenamine] (TAPC)/ TAPC: $MoO₃/MoO₃/Ag$, where they used a 1000 nm-thick perovskite film. They observed that the hole mobility of 18.804 cm^2 V^{-1} s⁻¹ is higher than the electron mobility of 8.968 cm² V⁻¹ s⁻¹. Most importantly, they reported that their device was selfpowered. In addition, the sensitivity of the device was observed at 1.2 C Gy⁻¹ cm⁻³ without a biasing voltage, which is the highest sensitivity among the presented research articles in this review paper. In addition, the LDDR was determined to be 25.69 nGy s^{-1} with no biasing voltage. Moreover, they recorded an X-ray image of a battery box. The different materials of the box were remarked as various shades of color. The plastic shell looked slightly bright; the copper electrode displayed an intermediate brightness and the button battery exhibited the highest brightest. This confirms that their device with $CsPbI₂Br$ is appropriate for application in X-ray imaging. Finally, the device maintained outstanding stability even after being subjected to more than 3000 times the cumulative radiation dose of a chest X-ray image. The entire procedure of film development, characterization, X-ray detection and imaging is depicted in Fig. 12. Review Warthout and the content of the content of the complete is likely article. The content of the complete properties are allowed under the complete the same in the common active Common and the common active Common and

Very recently, in 2023, C. Liu and research group fabricated a compact and homogeneous perovskite film by incorporating Sr^{2+} in CsPbBr₃ through the anti-solvent method.¹⁸¹ They scrutinized the impact of introducing Sr^{2+} in the perovskite material. They claimed that due to the incorporation of Sr^{2+} , the density and uniformity of the film significantly increased. For the purpose of performance evaluation, the adopted device structure was Au/PCBM/perovskite/PEDOT:PSS/ITO. The device performance was investigated under an X-ray source of 60 kV and a tube current of 0.3 mA. The sensitivity of the pristine CsPbBr₃ film-based detector was 288.11 µC $\text{Gy}^{-1} \text{ cm}^{-2}$, whereas

that of the device based on the structure of the CsPbBr₃:Sr film was as high as 517.02 µC Gy⁻¹ cm⁻³ under no bias, indicating that the device was self-powered. In addition, the LDDR was 0.955 nGy s^{-1} . These outstanding features specify that the substitution of Pb²⁺ by the alkali metal Sr^{2+} has immense potential for usage in Pb-free self-powered X-ray detectors. Finally, in 2023, another well-known research group led by S. Chen devised a strategy for developing a large-scale and flexible $CsPbBr₃$ film composed of extremely crystalline grains with no pinholes or micro-cracks by adopting an electro-spraying procedure.¹⁸² Film deposition took 180 min under ambient conditions. After electro-spraying deposition, to further increase the crystal quality of the perovskite films, the thin films were annealed at a succession of temperatures for 15 min. Subsequently, they characterized the material. The UV-Vis-NIR transmission spectrum-fitted band gap of the CsPbBr₃ film was 2.27 eV. In addition, the assembled inter-digital detector presented a resistivity of 1.14 \times 10⁹ Ω cm. They also conducted a performance test under an X-ray source of 20 kVp for the Au/ CsPbBr₃/PI device. The X-ray sensitivity of 823.12 µC Gy⁻¹ cm⁻² and the LDDR of 14.61 nGy s^{-1} were measured. Although some parameters including the resistivity and sensitivity were lower than that of the SC-based detectors, the LDDR of the film-based detectors was prominent. The fabrication technique, characterization and performance of the device are shown in Fig. 13.

4.2.3. Wafers. Although significant progress has been attained in the development of perovskite SCs and films, the conventional methods including spin coating, blade coating, inkjet printing and vacuum deposition face challenges in the production of large-area and thick perovskite films. Thus, to resolve these issues, researchers introduced wafer-like-shape perovskite to balance the thickness and surface area. However, sensitivity is inhibited due to the unavoidable introduction of voids, which reduces the effective interaction with radiation, consequently reducing the performance of the device. In 2019, B. Yang and colleagues developed a radiation detection device based on the $Cs₂AgBiBr₆–BiOBr w after.¹⁸⁵ Their adopted device$ structure was symmetric type with Au/perovskite/Au. To improve the wafer quality and reduce pinholes, they implemented an innovative substitution of the raw precursor materials (CsBr, AgBi, and BiBr₃) with perovskite powder $(Cs₂AgBiBr₆)$. In addition, they also applied an isostatic pressing technique to produce a large-area $Cs₂AgBiBr₆$ wafer. Furthermore, they integrated this wafer with a wide band-gap semiconducting material named bismuth oxybromide, BiOBr, through hetero-epitaxial growth to passivate grain boundaries, minimize dangling bonds, and hinder ionic migration. Consequently, the $Cs₂$ - $AgBiBr₆–BiOBr$ wafer displayed a substantially increased ionic migration energy of 360 meV compared to the pristine $Cs₂$ - $AgBiBr₆$ wafer with 203 meV. Eventually, the optimized device showed a moderate sensitivity of 250 μ C Gy⁻¹ cm⁻³ under the biasing electric field of 0.5 V mm⁻¹. In 2023, the eminent research team comprised of Y. Ba and colleagues developed an efficient CsPbBr₃-CsPb₂Br₅-CsPbI_xBr_{3-x} composite wafer-based X-ray radiation detector,¹⁸⁴ adopting the water-assisted coprecipitation and spray coating techniques. Particularly, the pressure-induced aggregation of the $CsPbBr_3-CsPb_2Br_5$ powder

Fig. 12 Surface appearance of perovskite films with different thicknesses: (a) 400 nm, (b) 600 nm, and (c) 1000 nm CsPbI₂Br on glass substrates and (d and e) AFM images in 10 µm scale for 400 nm and 600 nm, respectively. (f-k) X-ray detection by using the 1 µm CsPbI₂Br device. (f) Current densities were measured in the dark and under AM 1.5 G conditions (voltage range of [−]2 V to 2 V). (g) Photo-current density versus time for X-ray dose rates in the range of 1.02 μGy s^{−1} to 12.59 μGy s^{−1}. (h) Extracted photo-current densities produced from the respective dose rates. (i) SNRs
estimated at dose rates in the range of 9.34 nGy s^{−1} to 74.75 nGy s estimated at dose rates in the range of 9.34 nGy s^{−1} to 74.75 nGy s^{−1}. (j) Photo-current density v*ersus* time measured at 25.69 nGy s^{−1} dose rate (SNR = 3). (k) Normalized sensitivity of the device checked after 10 months. (l) Transient photo-current curve of the device measured by using a 635 nm pulsed diode laser (the light source). (m) Frequency response of the device. (n) Stability test of the device with illumination at a constant dose rate. (o) Battery box under closed and open conditions. (p) X-ray image of the object. Reprinted with permission from ref. 180. Copyright 2023@ the American Chemical Society.

formed by co-precipitation using an $H₂O/MeOH$ mixed solvent in the CsPbBr₃–CsPb₂Br₅ wafer was followed by spraying a CsI/ $\rm H_2O$ solution onto the wafer surface to extend it into a CsPbBr₃– $CsPb_2Br_5-CsPbI_xBr_{3-x}$ composite wafer. Using this approach, they avoided precursor wastage and formed larger grain sizes wafers. In addition, they achieved wafers with a uniform distribution, higher crystallinity, and fewer defects. Moreover, they investigated the optoelectronic properties of the wafer, where they had found a high $\mu\tau$ product of 1.01 × 10⁻³ cm² V⁻¹ and resistivity of 1.3 \times 10⁹ Ω cm. Finally, they fabricated a symmetric device with the structure of Ag/wafer/Ag for the performance test under an X-ray tube of Ag target material (Mini

X-ray, AMETEK) with an acceleration voltage of 45 kV. The sensitivity of the device was estimated to be as high as 20 555.1 μ C Gy⁻¹ cm⁻², which is superior to certain SC-based perovskite
detectors and unquestionably many times larger than some detectors and unquestionably many times larger than some commercial detectors.^{119-121,124,186}. In addition, they calibrated the LDDR, which was about 127.7 nGy s^{-1} . Finally, they performed a stability test, where they found no observable change in performance after 30 days. These exciting findings indicate that wafers, typically made of materials such as the $CsPbBr₃$ - $CsPb_2Br_5-CsPbI_xBr_{3-x}$ composite hold great promise as X-ray radiation detectors. The whole process including fabrication, characterization and detection is described in Fig. 14.

Fig. 13 (a and b) Photographs of a CsPbBr₃ film; (c and d) top view and cross-sectional SEM images of the film; (e) UV-Vis-NIR transmission spectrum; (f) band gap of CsPbBr₃ film fitted by a Tauc plot; (g) $I-V$ curves of the detector without and with X-ray at a biasing voltage of 1 V; (h) attenuation efficiency of various materials with a thickness in the range of $0-400 \mu m$; (i) $I-T$ curves of the device under biasing 9 V irradiated by 20 kVp X-rays; (j) sensitivity of the device with respect to different voltages; (k) I–T curves of the detector under a biasing voltage of 7 V and illuminated by X-rays of various dose rates; and (I) SNR of the CsPbBr₃ detector under different biasing voltages and dose rates. Reprinted with permission from ref. 182. Copyright 2023 @ The Royal Society of Chemistry.

4.3. Lead-free perovskite detectors

The outstanding optoelectronic features and diverse optoelectronic applications of perovskites have attracted interest from the scientific research community. They showed record performances in an optoelectronic devices including solar cells, LEDs, and radiation

detectors in comparison with traditional devices. However, the high-performance devices contain the toxic element lead, which has adverse effects on the environment due to its harmful nature. In this section, we discuss lead-free perovskite-based X-ray

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Fig. 14 (a) Schematic technique for the fabrication of CsPbBr₃–CsPb₂Br₅ powder by coprecipitation using H₂O/methanol (MeOH) mixed solvent. (b) Schematic method for the preparation of CsPbBr₃–CsPb₂Br₅–CsPbI_xBr_{3−x} wafer by spray coating by using CsI/H₂O solution. (c) Image of CsPbBr₃–CsPb₂Br₅–CsPb_{Ix}Br_{3−x} composite wafers. (d–g) SEM images of CsPbBr₃–CsPb₂Br₅–CsPbI_xBr_{3−x} wafers produced from (d) 0.0 M, (e) 1.0 M, (f) 1.5 M, and (g) 2.0 M CsI/H₂O solution. (h) XRD patterns; (i) UV-Vis reflection spectra; (j) $\mu\tau$ product curves; (k) resistivity (p) versus voltage (V) curves; (I) J–V curves recorded under the I_{dark} condition; (m) J–V curves with X-ray illumination; and (n) sensitivity plots for the CsPbBr₃–CsPb₂Br₅ wafer and the CsPbBr₃–CsPb₂Br₅–CsPbI_xBr_{3–x} composite wafer. (o) LDDR for the CsPbBr₃–CsPb₂Br₅ wafer and CsPbBr₃– CsPb₂Br₅–CsPbI_xBr_{3−X} wafer. (p and q) Current density versus time curves of X-ray detectors (p) without and (q) with X-ray irradiation; (r and s) current density versus time curves under different (r) radiation doses and (s) bias voltages for the detector and (t) long-term sensitivity test results. Reprinted with permission from ref. 184. Copyright@2023, Elsevier B.V. All rights reserved.

radiation detectors. Table 4 presents a compilation of the notable studies on lead-free perovskite-based X-ray detectors.

4.3.1. Single crystals. In 2017, W. Pan and research group fabricated a lead-free perovskite X-ray radiation detection device with the help of a $Cs_2AgBiBr_6$ SC.¹⁸⁷ The crystal growth was accomplished via a modified ITC method and the device structure was $Au/Cs_2AgBiBr_6/Au$. In addition, they employed a strategy to remove the toxic element lead from the structure of

Table 4 Lead-free perovskite-based X-ray detectors" Table 4 Lead-free perovskite-based X-ray detectors

 Bi^{3+} to substitute two Pb²⁺ in CsPbBr₃. They found an improved quality crystal structure, as evidenced by the lower trap density with the value of 1.74 \times 10⁹ cm⁻³. In addition, the high resistivity of 1.6 \times 10¹¹ Q cm and high carrier mobility of 11.81 cm² V^{-1} s⁻¹ were obtained, which are desirable for radiation detection. Consequently, the observed $\mu\tau$ of the crystal was 6.3 \times 10⁻³ cm² V⁻¹. Furthermore, they accomplished the detection performance by using a tungsten anode X-ray tube with photonenergy of up to 50 keV. The sensitivity and LDDR of the device were estimated to be 105 μ C Gy⁻¹ cm⁻³ and 59.7 nGy s⁻¹ under a biasing electric field of 25 V mm^{-1} , respectively. One year later, in 2018, the research group of Q. Sun fabricated a perovskite $Cs₃Bi₂I₉$ SC by employing the modified vertical Bridgman scheme for developing a radiation detector.¹⁸⁸ Their utilized device structure was Au/perovskite/Au. They investigated the anisotropy behavior of the crystal and found a large resistivity of \sim 10¹² Ω cm for the crystallographic [001] direction compared to \sim 10¹⁰ Q cm for the crystallographic¹⁰⁰ direction. This indicates that the device with the [001] crystallographic direction displayed better optoelectronic properties. As evidence, the mobility and $\mu\tau$ of the crystal were 6.10 cm 2 V $^{-1}$ s $^{-1}$ and 2.03 \times 10^{-5} cm² V⁻¹, respectively. The performance test of the device was carried out under a tungsten target X-ray tube with an operating voltage under 80 kVp. The sensitivity of the device was estimated to be 111.9 µC Gy^{-1} cm⁻³ under a biasing electric field of 450 V cm^{-1} . In another endeavor, in 2019, the prominent research team of L. Yin and colleagues fabricated two SCs from $Cs₂AgBiBr₆$ by utilizing natural cooling and a controlled cooling scheme.¹⁸⁹ They found that the crystal from the controlled cooling technique exhibited better crystal quality than that of the crystal from the natural cooling technique. In addition, the $Cs₂AgBiBr₆SC$ from the controlled cooling scheme displayed higher resistivity (with a narrow distribution of 6.10 \times 10^9 Ω cm to 3.31 \times 10¹⁰ Ω cm) than Cs₂AgBiBr₆ SC from the natural cooling scheme (ranging from 6.04 \times 10⁷ Ω cm to 5.61 \times 10⁹ Q cm). Moreover, the controlled cooling crystal structure attained a larger carrier mobility of 10.81 cm 2 V $^{-1}$ s $^{-1}$ than that of the natural cooling crystal structure of 1.70 cm² V⁻¹ s⁻¹. Subsequently, the $\mu\tau$ product of the controlled cooling sample was 5.95 \times 10 $^{-3}$ cm 2 V $^{-1}$, which was larger than that of the natural cooling sample (1.36 \times 10⁻⁴ cm² V⁻¹). They also conducted the performance evaluation by adopting the structure of $Au/Cs₂AgBiBr₆/Au$ under a tungsten anode with X-ray photonenergy of up to 50 keV. The sensitivity of the fabricated X-ray detection device was recorded to be 1974 µC Gy^{-1} cm⁻³ under a biasing electric field of 50 V mm $^{-1}$. In addition, the LDDR was 45.7 nGy s^{-1} . In 2020, the research group led by Y. Liu et al. synthesized a 0D-structured $MA_3Bi_2I_9$ SC perovskite by employing a precursor refinement approach to diminish extraneous nucleation seeds.¹⁹⁰ They claimed that they obtained a crystal structure with lower ion-migration, reduced darkcurrent, and better environmental stability in comparison with other perovskites. The reported electron-trap and the holetrap density values were 1.2 \times 10^{10} $\rm cm^{-3}$ and 7.5 \times 10^{10} $\rm cm^{-3},$ respectively. In addition, the $\mu\tau$ product was determined to be 2.87×10^{-3} cm² V⁻¹. The performance analysis was carried RSC Advances Weeklyness Article interpretation on 22 February 2022. The consideration of the common and the creation of the common and the creation of the creation of the common and the creation of the state of the state

 $CsPbBr₃$. For this purpose, they incorporated one Ag⁺ and one

using the structure of $Au/MA_3Bi_2I_9/Au$ under the irradiation of X-rays from a tungsten anode X-ray tube with a constant 40 kV accelerating voltage. The reported sensitivity of the device was as high as 1947 µC Gy⁻¹ cm⁻³ under the biasing electric field of 60 V mm−¹ . In addition, they also observed an LDDR of 83 nGy s^{-1} and a short response time of 23.3 ms. Moreover, a stability test was conducted, where they found that 98% efficiency was retained after 55 days of exposure to ambient condition. Another endeavor was launched in 2021 for fabricating radiation detectors by W. Li and research group. They developed a centimeter-sized zero-dimensional $FA_3Bi_2I_9$ SC with the help of a nucleation-controlled secondary solution constanttemperature evaporation approach.¹⁹¹ They found a low defect density and high resistivity as evidence of the good-quality crystal structure. Specifically, the trap density and resistivity of the structure were 9.48 \times 10⁹ cm⁻³ and 7.8 \times 10¹⁰ Ω cm, respectively. In addition, the electron and hole mobility was 0.016–0.034 cm² V⁻¹ s⁻¹ and 0.013–0.025 cm² V⁻¹ s⁻¹, respectively. Moreover, the $\mu\tau$ products for holes and electrons were 2.4×10^{-5} cm² V⁻¹ and 1.3 × 10⁻⁴ cm² V⁻¹, respectively. Furthermore, they investigated the performance of the device structure under the illumination of X-rays with a photon energy of 45 keV. The sensitivity of the detector was 598.1 µC Gy⁻¹ cm⁻² under the biasing voltage of 500 V. Finally, the detector displayed an LDDR of 0.2 μ Gy s⁻¹. In 2022, research team of X. Li
and colleagues februated a device by utilizing an SC of Ca and colleagues fabricated a device by utilizing an SC of $Cs₃$ -Bi₂Br₉ grown through the Bridgman method.³⁷ They obtained improved crystal quality by removing the CsBr-rich inclusions and reducing the trap-state density, resulting in a large resistivity of 1.41 × 10¹² Ω cm and $\mu\tau$ product of 8.32 × 10⁻⁴ cm² V⁻¹. The device with a structure of Au/Cs₃Bi₂Br₉/Au exhibited a high sensitivity of 1705 µC Gy⁻¹ cm⁻² and a very low LDDR of 0.58 nGy s^{-1} under 120 keV hard X-rays. Recently, in 2023, M. Yang et al. fabricated two X-ray detection devices using a $Cs_3Bi_2I_9$ SC with a size of 18 \times 20.5 \times 3 mm³.¹⁹² The two devices were vertical and co-planar type. The $\mu\tau$ product of the co-planar structure $(6.08 \times 10^{-3} \text{ cm}^2 \text{ V}^{-1})$ was higher than the vertical structure (5.53 \times 10⁻⁴ cm² V⁻¹) due to its anisotropic nature. The coplanar device demonstrated higher sensitivity with the value of 59 464.4 µC Gy⁻¹ cm⁻² than that of the vertical device with the value of 49 155.8 µC Gy^{-1} cm⁻² under a biasing voltage of 150 V. In addition, the opposite scenario was observed for the LDDR, where the vertical devices displayed a better performance. The LDDR was 1.27 nGy s⁻¹ and 13.5 nGy s^{-1} for the vertical and co-planar structure at a biasing voltage of 5 V, respectively. As part of another initiative, the well-known research group led by Y. Wang devised a strategy to fabricate zero-dimensional lead-free SC-based X-ray radiation detector.¹⁹⁴ For this purpose, they prepared a black bulk SC with $(DPA)_2BiI_9$ $(DPA = 1,5$ -diaminopentane) by means of a solvothermal reaction of hydrogen peroxide DMP and Bi_2O_3 . The $(DPA)_2BiI_9$ SC displayed resistivity of 5 \times 10¹⁰ Ω cm, which is meaningfully greater than the necessity for a commercial X-ray detector (10 9 Ω) cm), and even larger than that of a CZT detector $(10^{10} \Omega \text{ cm})$.¹⁹⁷ In addition, they inspected the charge carrier $\mu\tau$ product in $(DPA)_2BiI_9$ and found it to be anisotropic in nature. The vertical (c-axis) $\mu\tau$ product of (DPA)₂BiI₉ was ~1.2 × 10⁻³ cm² V⁻¹,

which was greater than the lateral $\mu\tau$ product (\sim 4 × 10⁻⁴ cm² V⁻¹). Moreover, they scrutinized the reason behind this anisotropic behaviour. They speculated that this was owing to the I^{3-} ion providing smooth charge carrier transport in the vertical direction, but the organic spacers separating the $[\text{BiI}_6]^{3-}$ octahedron in the lateral direction resulted in inferior charge carrier mobility. Furthermore, they prepared a detector along the c-axis (vertical axis) of the $(DPA)_2BiI_9$ SC and tested the performance of the device by adopting a tungsten anode X-ray with 70 keV photon energy. The device demonstrated an outstanding X-ray detection performance, including high X-ray sensitivity of 20 $570 \mu C Gy^{-1} cm^{-2}$, LDDR of 0.98 nGy s⁻¹ and fast response time
(154/162 pc). Finally, they evaluated the stability of the device (154/162 ns). Finally, they evaluated the stability of the device under a high dose rate (about 100 µGy s⁻¹) and low dose rate
(about 20 nGy s⁻¹⁾ The findings demonstrated that the detector (about 20 nGy s $^{-1}$). The findings demonstrated that the detector could withstand and endure the strong dose rate for over 300 min and continuous exposure to low dose rates for up to 150 h. Notably, there was no visible attenuation in the photocurrent, indicating a sustained, non-fatiguing state. These results indicate that the (DPA) ₂BiI₉ SC has high potential for use in X-ray detection. The significant results are depicted in Fig. 15.

4.3.2. Thin/thick films. In 2018, renowned research group of H. Li and colleagues developed a composite film of Cs_2 -AgBiBr₆ for the purpose of X-ray detection.¹⁹⁶ They synthesized the film by adopting a facile method, where a mixture of CsBr, AgBr and $BiBr₃$ and polymers containing hydroxyl functional groups were dissolved in DMSO. Subsequently, the solution was poured onto a glass substrate and dehydrated in a vacuum oven at 150 \degree C for h. They claimed that the film could be bent up to a radius of 2 mm without degrading its performance. The high resistivity of the composite film was observed to be 2×10^{11} Ω cm. In addition, they conducted a sensitivity test for the Au/ perovskite film/Au device under X-ray irradiation from a copper X-ray tube at 45 kV. The sensitivity of the radiation sensor was determined to be 40 μ C Gy⁻¹ cm⁻², which is greater
than that of conventional detectors such as $\tilde{\sigma}$ Se. Two vegres than that of conventional detectors such as α -Se. Two years later, in 2020, the research group of H. Zhang synthesized an allinorganic $Cs₂AgBiBr₆ film via the spin-coating technique.¹⁹⁷ To$ obtain the best-quality film, they optimized the dripping time of the anti-solvent isopropanol during spin coating, which was 60 s. Subsequently, a high-film quality was attained with a large electron–hole diffusion length of [∼]700 nm and a long carrier

Fig. 15 (a) Comparison of absorption coefficients of (DPA)₂Bil₉ with Si, CdTe and α -Se as photon energy functions and (b) $\mu\tau$ product of (DPA)₂BiI₉ along the c-axis. (c) I_{dark} density versus voltage (inset: vertical structure of the X-ray device); (d) X-ray sensitivities versus voltage; (e) SNR value with respect to dose rates; (f) response time of the on and off states; (g) SNR value from stability test and (h) long-term X-ray photocurrent stability test. Reprinted with permission from ref. 194. Copyright 2023 @ The Royal Society of Chemistry.

lifetime of ∼750 ns. They also carried out a performance test under the illumination of Bremsstrahlung radiation from a tungsten anode X-ray tube with a photon energy of up to 100 keV. The sensitivity and LDDR of the device were $1.8 \times 10^4 \mu C$ Gy^{-1} cm⁻² and 145.2 nGy s⁻¹ under a biasing voltage of 5 V, respectively. The research group claimed that their encapsulated device demonstrated a better performance even after two months. As a part of another endeavor, in 2021, Y. Haruta and research team fabricated a 92 μ m-thick Cs₂AgBiBr₆ film with columnar grains via a mist deposition method, which is an ultrasonic-assisted spray deposition method.¹⁹⁸ They also revealed the secret formula for columnar growth, which is the redissolution capability of the precursor solution. In addition, the resistivity of the film was assessed to be 1×10^{10} Q cm as expected for high-energy radiation sensing. The configuration of X-ray detector was of $W/Cs_2AgBiBr_6/Pt$. They also performed a sensitivity test and the obtained sensitivity of the device was 487 µC Gy⁻¹ cm⁻² under the biasing electric field of 109 V mm−¹ . In 2022, another initiative, led by S. Dong, was conducted for synthesizing X-ray detectors by adopting an OIH lead-free perovskite material. They fabricated a perovskite film of $MA₃Bi₂I₉$ by adopting a very facile technique named the doctor blade coating process for direct conversion X-ray energy.³⁸ They also added MACl as an additive to make the crystal growth rate sluggish to reduce the unexpected formation of pinholes within the film. Consequently, they obtained the best $\mu\tau$ with the addition of 10% MACl with values of 1.62 \times 10^{-6} cm² V⁻¹ and 1.17×10^{-6} cm² V⁻¹ for holes and electrons, respectively. In addition, the resistivity of the film was observed to be 3.38 \times 10¹¹ Ω cm. Moreover, the sensitivity and LDDR of the device were 100.16 μ C Gy⁻¹ cm⁻² and 98.4 nGy s⁻¹,
respectively under the biosing electric field of 2000 V cm⁻¹ respectively under the biasing electric field of -3000 V cm⁻¹. Finally, in 2023, the prominent research group led by K. Qin prepared two lead-free films of $Cs₂AgBiBr₆$ by means of spin coating utilizing the conventional annealing method and polyimide (PI) tape-assisted annealing method.¹⁹⁹ Present, most post-treatments rely on non-contact treatments, which may limit the benefit because the impact on the perovskites induced by direct contact is considerably more straightforward. Due to the strong heat resistance and low glue residual of the PI tape, they offered an annealing method with straightforward manipulation in a solvent environment with the support of PI tape for the perovskite layer post-treatment. It directly influences the perovskite, demonstrating the possibility of direct manipulation by operators, stimulating the recrystallization of the perovskite grains, and eliminating impurity substances. They performed the space-charge-limited current measurements on the two perovskite layers to estimate the trap density. They found that the trap density by the PI method was approximately 20% less than the conventional one, which proved the better crystallinity. In addition, they also observed a greater X-ray absorption coefficient for $Cs₂AgBiBr₆$ in comparison with commercial X-ray detectors such as Si, CdTe, and α -Se. Their implemented device structure was SiO_2 -Ti-Au/ Cs₂AgBiBr₆/PI with an effective area of 0.0021 $\rm cm^{-2}$. The device with the PI-assisted $Cs₂AgBiBr₆$ film exhibited a high X-ray sensitivity of 7.5 × 10^4 µC Gy⁻¹ cm⁻² and LDDR of 47 nGy RSC Advances Weeklyness Article on 22 February 2022. The measurement of the measurement

 s^{-1} , which are comparable to all commercial and advanced Pbbased perovskite X-ray detectors. The entire procedure of film development, characterization, and X-ray detection is depicted in Fig. 16.

4.3.3. Wafers. In 2020, the renowned research group of S. Tie and colleagues fabricated a wafer pellet for X-ray radiation detection using green MA₃Bi₂I₉ perovskite with the help of the cold isostatic-pressing technique.²⁰⁰ The pellet displayed a high resistivity of 2.28 × 10^{11} Ω cm and high balanced mobility of \sim 2 $\text{cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ for electrons and holes, which are crucial for low noise and weak X-ray detection by X-ray detectors. Subsequently, a high $\mu\tau$ product of the wafer was obtained with a value of 4.6 \times 10⁻⁵ cm² V⁻¹. Finally, they conducted the performance analysis for the configuration of Au/MA₃Bi₂I₉/Au. The LDDR of the device was 9.3 nGy s^{-1} . In addition, the sensitivity towards X-rays reached 563 µC Gy^{-1} cm⁻³ under a 2100 V cm^{-1} bias field, which was 28-times larger than that of the α -Se radiation sensor functioning at a high biasing field of 100 000 V cm−¹ . The prominent research group led by W. Li adopted an approach to build a wafer-type radiation detector by combining $Cs_2AgBiBr_6$ perovskite with the $(C_{38}H_{34}P_2)MnBr_4$ scintillator through a fast tableting processes in 2021.²⁰¹ Basically, $(C_{38}H_{34}P_2)MnBr_4$ decreased the I_{dark} and noise of the device and enhanced its operating stability by blocking the migration routes of the $Cs₂AgBiBr₆$ ions at the grain boundaries. They also provided a path for the functioning of the device while avoiding undesirable light scattering, self-absorption, and even afterglow effects of scintillators. Particularly, the majority of the charges produced by $(C_{38}H_{34}P_2)MnBr_4$ were transported to the nearby $Cs₂AgBiBr₆$, and then recombined to emit light through scintillation. This light was then again absorbed by the neighboring $Cs₂AgBiBr₆$ structure and further induced collectable charge carriers for indirect X-ray detection. The resistivity and $\mu\tau$ product of the hybrid wafer were 8 \times 10¹¹ Ω cm and 8.5 \times 10^{-5} cm² V⁻¹, respectively. With an LDDR of 0.2 µGy s⁻¹ and
a bigh consitivity of 114 uC Cu^{-1} am⁻² under bard Y rays (120 a high sensitivity of 114 µC Gy⁻¹ cm⁻² under hard X-rays (120 keV), the hybrid X-ray radiation detector exhibited a 75-times lower LDDR than the $(C_{38}H_{34}P_2)MnBr_4$ scintillator. In 2022, another research team of C. Zhang developed two X-ray radiation sensors with the configuration of vertical $Au/Cs_3Bi_2I_9/Au.^{202}$ To fabricate the $Cs₃Bi₂I₉$ wafer, they utilized two methods. In the first method, DMSO and DMF component solvents (DMSO: $DMF = 7:3$ were used to dissolve CsI and BiI₃ at a mole ratio of $3:2$. This mixture was immediately stirred and left at room temperature for 12 h. Then the clear saturated solution was filtered through a PVDF filter $(0.8 \mu m)$ into the anti-solvent isopropyl IPA. Later, they centrifuged the orange turbid liquid and removed the supernatant liquid and added the necessary amount of IPA to the centrifuge tube. The sediment was then dried for 12 h under a vacuum. According to process two, CsI and $BiI₃$ were combined in an agate jar with agate balls using the same mole ratio and milled for 8 h. The powders were also made using the aforementioned technique. The $Cs₃Bi₂I₉$ wafer with the first method exhibited higher resistivity (2.21 \times 10⁹ Ω) cm) than that of the $Cs₃Bi₂I₉$ wafer obtained with the second method (5.13 \times 10⁸ Ω cm). Consequently, the X-ray radiation detector based on the anti-solvent-treated $Cs_3Bi_2I_9$ wafer

Fig. 16 (a and b) Top-view SEM images of Cs₂AgBiBr₆ films with different scales: films were fabricated via traditional annealing and PI tapeassisted annealing methods; (c) cross-sectional SEM images of the films; (d) statistics for the distribution of the perovskite crystal grain size with different annealing techniques; (e) AFM image of the PI-assisted film with the RMS (schematic diagram of annealing in inset); (f) comparison of AFM images prepared by PI-assisted techniques (upper) and conventional methods (lower) with their RMS; (g and h) I–V relation of different films and the matching result (schematic illustration of the device in inset); (i) absorption coefficient for various X-ray energies of different materials; (j) current change with different dose rates of X-rays; (k) sensitivity and SNR of the PI-assisted film at different dose rates of X-rays; (l and m) $I-T$ response of the detector under 47 nGy s^{−1} and 470 nGy s^{−1}, respectively; and (n) comparison of numerous X-ray detectors such as commercial ones and other perovskites. Reprinted with permission from ref. 199. Copyright 2023 @ the American Chemical Society.

displayed better sensitivity and lower detection limit (sensitivity of 588 µC Gy s^{−1} cm^{−2} and LDDR of 76 nGy s^{−1}) than that of the
HEPM (seeond mothod) based Cs_Bi_I_ugfor (sensitivity of 542 HEBM (second method)-based Cs₃Bi₂I₉ wafer (sensitivity of 543 µC Gy s⁻¹ cm⁻² and LDDR of 155 nGy s⁻¹) under a biasing
electric field of 28.8 V mm⁻¹ electric field of 28.8 V mm^{-1} .

Our investigation of the literature indicated that many researchers have suggested substituting conventional X-ray detectors including α -Se, CdTe, Bi₂O₃, InSe, and TIPS with Xray detectors based on perovskite materials.¹¹⁹–122,124,126,127,131,133 This shift is motivated by the superior X-ray attenuation ratio, heightened defect tolerance, extended carrier lifetime, and increased electron-hole drift length displayed by perovskite materials.²⁰³ Furthermore, the usage of emerging perovskite materials in X-ray detectors has confirmed the enhanced X-ray detection capabilities at a reduced cost and with minimal environmental influence.

In the initial phase of our investigation on organic– inorganic-based X-ray detectors, our focus on SCs, films, and wafers revealed their superior performance in X-ray detection. Various research groups have emphasized the advantages of employing SC perovskite-based detectors as substitutions for conventional detectors such as α -Se and CdTe in X-ray detection systems. These SC-based detectors displayed overall heightened responsiveness to X-ray irradiation, which is attributed to their exceptional crystalline quality, smooth morphology, high bulk resistivity, low trap density, and adequate thickness for effective X-ray attenuation. In addition to SCs, polycrystalline perovskitebased X-ray detectors, including films and wafers, have also established their enhanced performance in comparison with the widely used detectors such as α -Se and CdTe.^{147,158}. This improvement is attributed to advancements in synthesis methodologies and optimization of materials and device architectures. Our literature review disclosed that the ITC method is a popular route that is being employed by researchers for the fabrication of SCs. Notably, the highest performance was attained by the X-ray detector with an MAPbBr₃ SC formed via this approach, displaying a sensitivity of 2.35 \times 10⁵ µC Gy⁻¹ $\rm cm^{-2}$ and LDDR of 15.7 nGy s⁻¹.¹³⁷ In addition, a successful Xray image of a hex nut was recorded with this direct-conversion pixelated device. However, the device with the SC of MAPbI₃, developed by using the ITC method, exhibited the minimal LDDR, measuring at 2.34 nGy s^{-1} .¹³⁵ Conversely, for the filmbased detectors, ultrasound-assisted crystallization combined with post-hot-pressing technique was employed to fabricate a quasi-monocrystalline thick film of $MA_{0.42}FA_{0.58}PbI₃$, and the device with this film displayed a superior performance with a sensitivity of 1.16 × 10⁶ µC Gy⁻¹ cm⁻² and the LDDR of the device was recorded to be 37.4 nGy s^{-1} .¹⁴⁷ Notably, the film of $FA_{0.5}MA_{0.5}PbI₃$ made up through the blade-coating method exhibited the minimal LDDR with the value of 1.5 $\mathrm{nGy\,s}^{-1}$.⁵¹ On the contrary, in the case of wafer-based detectors, our study highlighted that the X-ray detector with a wafer of $MAPbI₃$ grown through a one-step heat-assisted high-pressure press scheme displayed a better performance than other wafer-based X-ray detectors, achieving a sensitivity of 1.22 \times 10⁵ µC Gy⁻¹ $\rm cm^{-2}.^{155}$ Nevertheless, the device of the MAPbI₃ wafer with the minimal LDDR of 0.22 nGy s^{-1} was prepared through the mechanical sintering of an independent absorber layer and subsequent incorporation onto a pixelated backplane.¹⁵⁶ RSC Advances

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Alternatively, regarding all-inorganic perovskite-based detectors, X-ray detectors with an SC of $CsPbBr_{2.9}I_{0.1}$, synthesized using the Bridgman method, which is another popular method for fabrication of SCs, exhibited the highest sensitivity of 6.3 \times 10⁴ µC Gy⁻¹ cm⁻² among the all-inorganic perovskitebased X-ray detectors and the minimal LDDR of 22 nGy s^{-1} was recorded for the device by utilizing the SC of CsPbBr₃ prepared through the same method.^{173,175} Conversely, the device with a film of $CsPbI_2Br$, manufactured via the vacuum-deposition

technique, demonstrated the highest sensitivity of 1.2 \times 10⁶ μ C Gy⁻¹ cm⁻².¹⁸⁰ However, the X-ray detector derived from the film of CePbPr^{2.6}5. group by adopting the anti-solvent method film of CsPbBr3:Sr, grown by adopting the anti-solvent method, displayed the minimal LDDR of 0.955 nGy s^{-1} .¹⁸¹ On the contrary, regarding wafer-based X-ray detectors, the device with the CsPbBr₃-CsPb₂Br₅-CsPbI_xBr_{3-x} composite wafer, developed through water-assisted co-precipitation and spray coating, unveiled the best sensitivity of 20 555.1 µC Gy^{-1} cm⁻² among the wafer-based X-ray detectors.¹⁸⁴ However, the device from the wafer of $Cs₂AgBiBr₆–BiOBr$, synthesized by employing isostatic pressing, recorded a minimal LDDR of 95.3 nGy s^{-1} .¹⁸⁵

In the concluding segment of our review on lead-free perovskite-based detectors, the X-ray detector employing an SC of $Cs₃Bi₂I₉$, developed using a solution evaporation process, demonstrated an outstanding performance, attaining a sensitivity of 59 464.4 µC Gy⁻¹ cm⁻² and the LDDR was recorded to be 13.5 nGy s $^{-1}$.¹⁹² However, another SC-based detector utilizing CsCu₂I₃ exhibited the minimal LDDR of 0.93 nGy s⁻¹.¹⁸⁶ Conversely, among the lead-free film-based detectors, the X-ray detector utilizing a film of $Cs₂AgBiBr₆$, grown through spincoating, displayed the best performance with a sensitivity of 7.5 × 10⁴ µC Gy⁻¹ cm⁻² and the minimal LDDR also was observed at 47 nGy s^{-1} by the same device.¹⁹⁹ On the contrary, in the field of lead-free perovskite wafer-based detectors, the device with the $Cs₃Bi₂I₉$ wafer prepared through anti-solvent treatment and pressing (24 tons) showed the best sensitivity of 588 $\rm \upmu C$ Gy $^{-1}$ cm $^{-2}$ among the lead-free wafer-based detectors, while the $MA₃Bi₂I₉$ -based detector displayed the minimal LDDR of 9.3 nGy s⁻¹.^{200,202}

Our data analysis specified that organic-inorganic X-ray radiation detectors exhibited superior performances in terms of sensitivity, LDDR, and imaging compared to all-inorganic and lead-free perovskite-based X-ray detectors. Alternatively, very few studies suggested that film-based X-ray detectors demonstrated the highest sensitivity in the case of organic– inorganic, all-inorganic, and lead-free perovskite detectors. However, most researchers reported that SC perovskite-based detectors displayed the best performance. Interestingly, waferbased detectors exhibited poor performances, particularly in the case of lead-free perovskite materials. The superiority of single crystallization techniques lies in the fact that devices based on SCs display a lower trap density, higher resistivity, increased carrier mobility, and longer carrier lifetime in comparison with film and wafer-based X-ray detectors. Consequently, SC-based devices revealed exceptional sensitivity and LDDR. These outcomes exceeded the performance of some conventional commercial X-ray radiation detectors such as amorphous selenium and CZT-based X-ray detectors. Alternatively, the limited performance of film-based devices is attributed to the formation of defects in the bulk film, surfaces, and grain boundaries. Conversely, the wafer-based devices unveiled the poorest performances due to the creation of voids, which inhibit the movement of charge carriers. It is worth noting that various research groups achieved high-performance devices with enhanced stability through the modification of synthesis methods, compositional engineering, and device architectures. However, although the removal of lead addresses

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Table 5 Summary of various parameters in the development of different types of perovskite-based radiation sensors			
	Device fabricated with		
	Single crystal	Thin/thick film	Wafer
Fabrication method	This type of perovskite material was fabricated using some established methods such as inverse- temperature crystallization ^{75,76} temperature-lowering crystallization, ⁸² slow solvent evaporation method, ⁹⁰ anti-solvent vapor-assisted crystallization, ⁹² and Bridgman synthesis method ¹⁰²	Thin/thick film-type perovskite materials were fabricated using several conventional methods including the spin coating process, ¹⁰³⁻¹⁰⁵ spray deposition process, ¹⁰⁷ inkjet printing method, ¹¹¹ and doctor blade method ¹¹⁴	It is a limited fabrication technique. The common technique is an isostatic-pressing method ¹⁸²
Size and cost	Forming large-size single crystals of perovskite poses challenges including controlling the crystal growth rate, time-consuming preparation, and incapability for realizing flexible devices ^{81,204}	Fabricating large-scale films is comparatively straightforward, involving shorter preparation times and yielding sizable, wearable devices ²⁰⁵	Developing large-sized wafers is also a challenging task
Quality	Achieving single crystals with minimal cracks has been successful ⁶⁴	Film quality surpasses that of wafers, but fewer single crystals are observed ⁶⁴	The perovskite layer quality is relatively poor
Trap density	Crystals with relatively low trap density have been observed. The lowest trap density was 8.22 \times 10 ⁸ cm^{-3} (ref. 134)	Trap density in film is lower than in wafers but higher than in single crystals. The trap density reached its minimum at 1.5×10^{10} cm ⁻³ (ref. 206)	The perovskite layers exhibit the highest trap density. The exceptional result has also been observed such as one research group reported the lowest trap density of 6×10^8 cm ⁻³ (ref. 149)
Mobility-lifetime product	Relatively high mobility-lifetime products $(\mu \tau)$ have been witnessed. In addition, the observed highest $\mu\tau$ was 1.847×10^{-2} cm ² V ⁻¹ (ref. 183)	A high mobility-lifetime product has been attained. Furthermore, the recorded highest $\mu\tau$ was 1.32 \times 10 ⁻² $\text{cm}^2 \text{ V}^{-1}$ (ref. 174)	A relatively poor mobility-lifetime product has been reported. Furthermore, the highest observed $\mu\tau$ was 5.51 \times 10 ⁻³ cm ² V ⁻¹ (ref. 182)
Sensitivity	The average sensitivity of the devices has been observed as the highest. Individually, one research group has attained as high as 2.35 \times 10^5 µC Gy ⁻¹ cm ⁻² (ref. 134)	The average sensitivity in film lies between wafers and single crystal- based devices, with a level higher than that of wafers but lower than that of single crystals. Few exceptional results were also observed in the case of film-based devices such as one research group achieved the highest sensitivity of $1.2 \times 10^6 \mu C Gy^{-1} cm^{-2}$ (ref. 177)	Relatively poor sensitivity has been achieved. Individually, one research group accomplished as high as 1.22 \times 10 ⁵ µC Gy ⁻¹ cm ⁻² (ref. 152)
LDDR	Overall, a reduced LDDR has been noted. In addition, one research team reported an LDDR as low as 0.93 nGy s^{-1} (ref. 183)	Overall, a lower LDDR has been achieved. In addition, one research team stated an LDDR as low as 0.955 nGy s^{-1} (ref. 178)	A relatively high LDDR has been achieved. In addition, exceptional results were also observed. One research team stated an LDDR as low as 0.22 nGy s^{-1} (ref. 153)
Image	Very few studies conducted the image recording performance	Only a handful of studies evaluated the performance of image recording	Only a few studies assessed the performance of image recording
Spatial resolution	A few studies provided information of the spatial resolution of the images. The highest reported spatial resolution was 10 line pairs per millimeter ¹²⁸	Only a few studies offered insights into the spatial resolution of the images. The highest stated spatial resolution was 3.3 line pairs per millimeter ¹⁴⁷	Several studies furnished information regarding the spatial resolution of the images. The highest reported spatial resolution was of 6 line pairs per millimeter ¹⁵³
Stability	Very few studies conducted a stability test. Stability is not up to the mark for commercialization. ¹⁸⁷ However, they showed relatively better stability than their film and wafer counterparts ⁶⁴	The stability tests were conducted infrequently. The stability does not meet the standards required for commercialization. ¹¹⁴ However, the results indicate a higher level of stability compared to wafers and lower than that of crystals ⁶⁴	Stability tests seldomly conducted. The stability falls short of the standards required for commercialization. ¹⁵¹ However, in general, it shows lower stability than that crystals and films

environmental concerns, lead-free perovskite based detectors demonstrated relatively inferior performances compared to other types of perovskite-based detectors. Thus, further investigation is essential to comprehend why lead-free perovskite materials demonstrated relatively poorer performances.

Halide perovskites have shown promising developments in X-ray detection, but several challenges remain that must be addressed for their wide-ranging commercial applications. Addressing these challenges should focus on enhancing the stability of materials, improving fabrication methods to attain a uniform perovskite layer with reduced trap density and costeffectiveness. In addition, it is necessary to explore large-area flexible X-ray detection technology, aiming to improve the sensitivity and lower detection limits. Tackling these challenges is crucial for motivating the future advancements in this field. Some measures may be executed to boost the overall performance of the devices. These include fabricating lowdimensional perovskite materials, incorporating passivated layers or interfacial design to mitigate the impact of ionic migration, developing X-ray radiation detectors based on inorganic perovskites for relatively high stability, optimizing structural design and fabrication methods, adopting lowdimensional perovskite resources in conjunction with 0D/1D/ 2D materials, optimizing perovskite materials with a high atomic number, and improving film deposition techniques. Additionally, fabricating perovskite SCs requires careful attention to the challenges associated with perovskite films and wafers. Although some studies have addressed these aspects, further research is necessary before implementing these strategies on a broad scale in the field of X-ray detection. A comparative study in tabular form among single crystals, thin/ thick film, and wafer-based devices is provided in Table 5. RSC Advances Constraines, insiddice provide based decretor an anti-provide with de science of the second of the second one of the s

5. Anti-perovskite-based radiation detectors

The anti-perovskite material is explained with the stoichiometry formula of M_3BA , where, M denotes a cation, and A and B represent different-sized anions.²⁰⁷ Specifically, the B anions are positioned in the center of 6-fold-coordinated octahedra and the A anions are 12-fold coordinated with the M cations. The 3D skeleton structure is made up of corner-sharing $BM₆$ octahedra. $Ca₃AsN$ and $Ba₃BiN$ are examples of anti-perovskites. In comparison with conventional perovskites, the cations replace anions in the octahedra, and these numerous M site cations form anti-perovskites with unusual physical and chemical features linked to d-spin states/the band structure or ion transportation.²⁰⁸ The conventional perovskites frequently display deficiencies or non-stoichiometry, resulting in intriguing structural types and noteworthy optoelectronic features. Oxygen-deficient brownmillerite $CaFeO_{2.5}$ and LaNiO_{2.5}, as well as ReO₃-type compounds (A site unoccupied), are common examples. Similarly, in 2017, the well-known research group led by Y. He reported the vapor transport synthesis of Hg₃Q₂I₂ (Q = S, Se, and Te) SCs with an antiperovskite structure.²⁰⁷ The Hg₃Q₂I₂ SC structure was defective

an anti-perovskite with the stoichiometry formula of $Hg_6Q_2X_2$, where 50% of the Hg atoms were absent to give the $Hg_3Q_2X_2$ composition.²⁰⁹ These compounds have a high density $($ >7 $\rm g$ $\rm cm^{-3})$ and broad bandgaps (>1.9 eV), resulting in excellent hard radiation-stopping power and a high inherent electrical resistivity of over 10^{11} Ω cm. In addition, the $\mu\tau$ product for Hg₃Q₂I₂ detectors was achieved in the range of 10⁻⁵ cm² V⁻¹ to 10^{-6} cm² V⁻¹. These intriguing characteristics are required in high-energy radiation detection and imaging. As a part of another initiative, the research group led by W. Lin prepared centimeter-size $TISn₂I₅$ 2D SCs by the Bridgman method for use in radiation detection devices. In comparison with MAPb X_3 (X = Br, I), the anti-perovskite $TlSn₂I₅$ showed higher long-term stability, higher photon stopping power (average atomic number of 55), higher resistivity ($\sim 10^{10}$ Ω cm), and robust mechanical properties. In addition, the device $\mu\tau$ product was estimated to be 1.1 \times 10⁻³ cm² V⁻¹. Moreover, the device detected the radiation of K α from Ag X-rays (22 keV), γ from ⁵⁷Co (122 keV), and α -particles from ²⁴¹Am (5.5 MeV). These features indicate that anti-perovskite materials are prospective candidates for radiation detection.

6. Conclusion

Perovskite materials have been extensively explored as X-ray radiation detectors for a wide range of applications in the fields of medical imaging, non-destructive industrial inspection, and safety screening. Chronologically, we conducted an extensive review to infer the current scenario of X-ray detection by OIH, all-inorganic and lead-free perovskite-based SCs, films, and wafers. Particularly, we investigated the innovation and modification of a cost-effective synthesis process, the material evolution, and the device architectural modification. It has been observed that the improvement in crystallization techniques dominated the film and wafer growth techniques. The reason for this superiority of the crystallization techniques is that crystal-based especially SC-based devices display a lower trap density, higher resistivity, large carrier mobility and lifetime compared to film and wafer-based devices. Eventually, the devices with SCs showed outstanding sensitivity and LDDR. These results are much better than that of some traditional commercial X-ray radiation detectors such as amorphous selenium- and CZT-based X-ray radiation detectors. In addition, the reasons for the limited device performance of film-based devices include defect formation in the bulk film, surfaces, and grain boundaries. However, wafer-based devices show a lower performance because of the formation of voids, which impede the transportation of charge carriers. We also observed that by performing structural modification, various research groups achieved high-performance devices together with stability. However, although the advancements in perovskite materials and devices for X-ray radiation detection have displayed promising performances, they still face critical challenges for real-world applications. These problems can be resolved by increasing the material stability, improving the fabrication techniques to obtain uniform, lower trap density and cost-effective perovskite layers, and investigating large-area

flexible X-ray detection technology with improved sensitivity and lower detection limits. Thus, addressing these challenges is essential for future innovations in this field. Some measures may be executed to boost the overall performance of the devices including preparing low-dimensional perovskite materials, using passivated layers or interfacial design to reduce the effect of ion migration, producing inorganic perovskite-based X-ray radiation detectors, optimizing structural design and fabrication methods, using low-dimensional perovskite resources in conjunction with 0D/1D/2D materials, optimizing perovskites with a high atomic number and improving film deposition methods, and fabricating perovskite SCs by paying closer attention to the hurdles regarding perovskite films and perovskite wafers. However, although there have been some studies on this matter, much more study is required before it can be adopted in X-ray detection. We should maintain an optimistic mindset as well as devise distinctive strategies to bring them to market. Review Waterion technology with improved sensitivity 2 Y. Yang, Y. Su, W. Ma and Y. M. Yang, Provedicion and Howard Commonstration for the desired under a Creation and Howard Commonstration and Howard Commonstration in th

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Data availability

All data are available in the manuscript.

Author contributions

M. H. M. developed the concept and wrote the main manuscript, M. U. K., M. A. I., M. N. A., H. O. and M. H. U. reviewed the manuscript, M. U. K. Supported the theoretical methodology and computational packages, M. U. K., M. A. I., M. N. A., H. O. and M. H. U. provided technical, theoretical and conceptual reviews.

Conflicts of interest

The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper.

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